

# DACx0004, Quad 16-,14-,12-Bit, 1 LSB INL, Buffered, Voltage-Output Digital-to-Analog Converters

## 1 Features

- True 16-Bit Performance: 1 LSB INL/DNL (Max)
- Ultra Low Glitch Energy: 1 nV-s
- Wide Power-Supply Range: 2.7 V to 5.5 V
- Output Buffer with Rail-to-Rail Operation
- Current Consumption: 1 mA/Channel
- 50-MHz, 4- or 3-Wire SPI Compatible Interface
- SDO Pin for Readback and Daisy Chain
- Power-On Reset to Zero or Mid Scale
- Temperature Range:  $-40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$
- Multiple Packages:
  - Tiny 14-Pin VSON
  - 14-Pin TSSOP

## 2 Applications

- Portable Instrumentation
- PLC Analog Output Module (4-20 mA)
- Closed-Loop Servo Control
- Data Acquisition Systems

## 3 Description

The DAC80004/70004/60004 (DACx0004) are highly accurate, low-power, voltage-output, quad-channel, 16-, 14-, 12-bit digital-to-analog converters (DACs) respectively. The DACx0004 devices are ensured monotonic by design and offer excellent linearity of less than 1 LSB (Max). The reference input of the DAC is buffered internally using a dedicated reference buffer.

The DACx0004 devices incorporate a power-on-reset circuit that ensures the DAC output powers up at zero scale or mid scale depending on status of the POR pin and remains in this state until a valid code is written to the device. These devices consume very low current of 1 mA/channel making them ideal for portable, battery-operated equipment. These devices also contain a power-down feature that reduces current consumption to typically 3  $\mu\text{A}$  at 5 V.

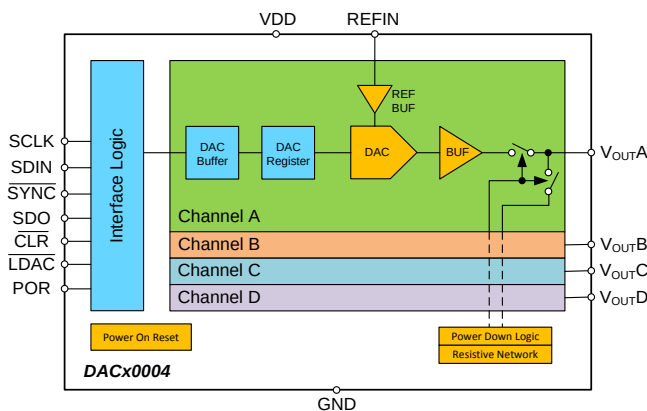
The DACx0004 devices use a versatile 4- or 3-wire serial interface that operates at clock rates up to 50 MHz. The DACx0004 devices also include a SDO pin to daisy chain multiple devices. The interface is compatible with standard SPI™, QSPI™, Microwire, and digital signal processor (DSP) interfaces. The DACx0004 devices are offered in easy-to-assemble 14-pin TSSOP packages or an ultra small 14-pin VSON package and are fully specified over the extended industrial temperature range of  $-40^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ .

### Device Information<sup>(1)</sup>

| PART NUMBER | PACKAGE    | BODY SIZE (NOM)   |
|-------------|------------|-------------------|
| DACx0004    | VSON (14)  | 3.00 mm x 4.00 mm |
| DACx0004    | TSSOP (14) | 5.00 mm x 4.40 mm |

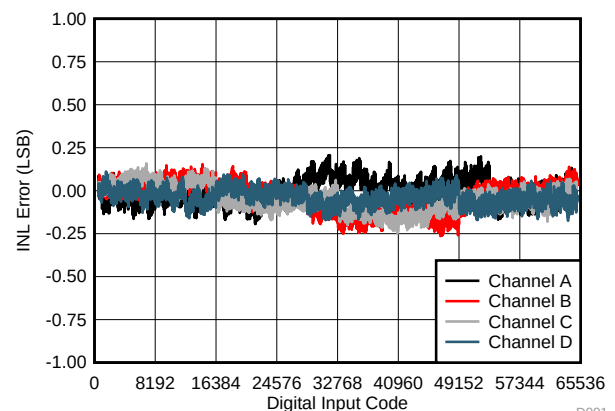
(1) For all available packages, see the orderable addendum at the end of the data sheet.

### DACx0004 Block Diagram



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### Linearity Error vs Digital Input Code



D001



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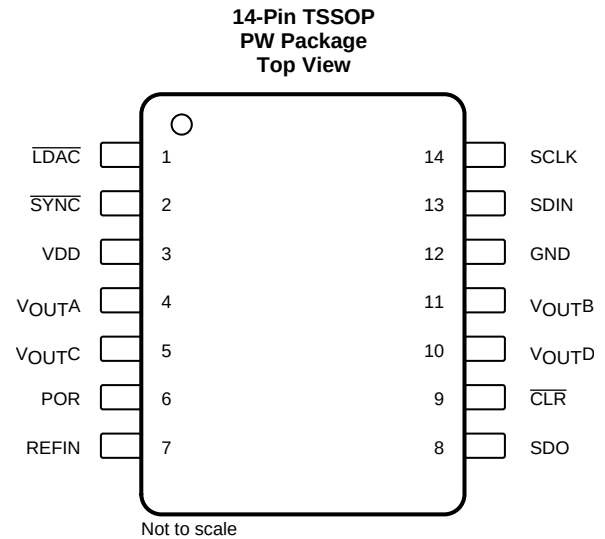
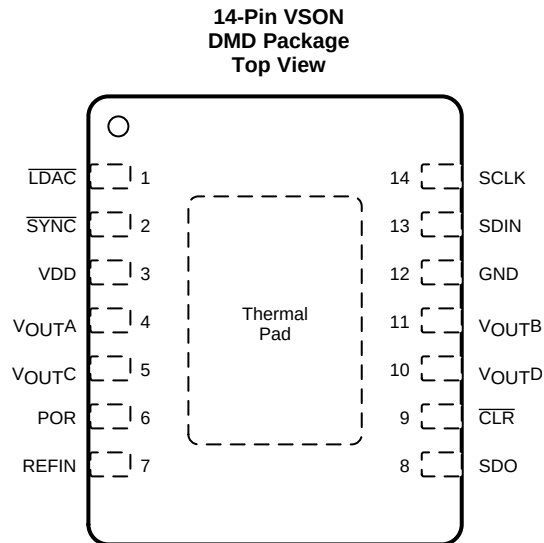
## 4 Revision History

| Changes from Revision C (August 2016) to Revision D                                                                   | Page      |
|-----------------------------------------------------------------------------------------------------------------------|-----------|
| • Changed 2.4 $\mu$ s From MAX to MIN value for $t_{20}$ in the <i>DACx0004 Timing Requirements</i> table .....       | <b>8</b>  |
| • Changed From: $t_{19}$ To: $t_{20}$ in <a href="#">Figure 1</a> .....                                               | <b>8</b>  |
| Changes from Revision B (June 2016) to Revision C                                                                     | Page      |
| • Deleted thermal pad from PW-TSSOP pin configuration .....                                                           | <b>3</b>  |
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| • Added DAC80004IPW Device Marking Addendum to <a href="#">Mechanical, Packaging, and Orderable Information</a> ..... | <b>31</b> |
| Changes from Original (April 2016) to Revision A                                                                      | Page      |
| • Changed from Product Preview to Production Data .....                                                               | <b>1</b>  |

## 5 Device Comparison Table

| DEVICE   | RESOLUTION |
|----------|------------|
| DAC80004 | 16         |
| DAC70004 | 14         |
| DAC60004 | 12         |

## 6 Pin Configuration and Functions



### Pin Functions

| PIN   |        | I/O            | DESCRIPTION                                                                                                                                                        |
|-------|--------|----------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| NAME  | NUMBER |                |                                                                                                                                                                    |
| CLR   | 9      | Digital Input  | Clear DAC pin, falling edge sensitive                                                                                                                              |
| GND   | 12     | Power          | Ground                                                                                                                                                             |
| LDAC  | 1      | Digital Input  | Load DAC pin, active low                                                                                                                                           |
| POR   | 6      | Digital Input  | Power-on-reset configuration, Connecting the POR pin to GND powers up all four DACs to zero scale. Connecting this pin to VDD powers up all four DACs to midscale. |
| REFIN | 7      | Analog Input   | Voltage reference input for all channels                                                                                                                           |
| SCLK  | 14     | Digital Input  | Serial interface shift clock                                                                                                                                       |
| SDIN  | 13     | Digital Input  | Serial interface digital input                                                                                                                                     |
| SDO   | 8      | Digital Output | Serial interface digital output for readback and daisy chaining                                                                                                    |
| SYNC  | 2      | Digital Input  | Serial interface synchronization, active low                                                                                                                       |
| VDD   | 3      | Power          | Positive power supply (2.7 V to 5.5 V)                                                                                                                             |
| VOUTA | 4      | Analog Output  | DAC A output                                                                                                                                                       |
| VOUTB | 11     | Analog Output  | DAC B output                                                                                                                                                       |
| VOUTC | 5      | Analog Output  | DAC C output                                                                                                                                                       |
| VOUTD | 10     | Analog Output  | DAC D output                                                                                                                                                       |

## 7 Specifications

### 7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) <sup>(1)</sup>

|                                                                     | MIN  | MAX                   | UNIT |
|---------------------------------------------------------------------|------|-----------------------|------|
| Voltage, VDD to GND                                                 | −0.3 | 7                     | V    |
| Voltage, digital input or output to GND                             | −0.3 | V <sub>DD</sub> + 0.3 | V    |
| Voltage, analog input (REFIN) or output (V <sub>OUTX</sub> ) to GND | −0.3 | V <sub>DD</sub> + 0.3 | V    |
| Input current to any pin except supply pins                         | −10  | 10                    | mA   |
| Maximum junction temperature                                        |      | 150                   | °C   |
| Storage temperature range, T <sub>stg</sub>                         | −60  | 150                   | °C   |

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### 7.2 ESD Ratings

|                                            |                                                                                          | VALUE | UNIT |
|--------------------------------------------|------------------------------------------------------------------------------------------|-------|------|
| V <sub>(ESD)</sub> Electrostatic discharge | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>              | ±2000 | V    |
|                                            | Charged device model (CDM), per JEDEC specification JESD22-C101, all pins <sup>(2)</sup> | ±1000 |      |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

|                                                                     | MIN                             | NOM | MAX                   | UNIT |
|---------------------------------------------------------------------|---------------------------------|-----|-----------------------|------|
| Voltage, VDD to GND                                                 | 2.7                             |     | 5.5                   | V    |
| Voltage, analog input (REFIN) or output (V <sub>OUTX</sub> ) to GND | 2.7 V ≤ V <sub>DD</sub> ≤ 4.5 V | 2.2 | V <sub>DD</sub> − 0.2 | V    |
|                                                                     | 4.5 V ≤ V <sub>DD</sub> ≤ 5.5 V | 2.2 | V <sub>DD</sub>       | V    |
| Ambient Operating Temperature, T <sub>A</sub>                       | −40                             |     | 125                   | °C   |

### 7.4 Thermal Information

| THERMAL METRIC <sup>(1)</sup> |                                              | DACx0004   |            | UNIT |
|-------------------------------|----------------------------------------------|------------|------------|------|
|                               |                                              | DMD (VSON) | PW (TSSOP) |      |
|                               |                                              | 14 PINS    | 14 PINS    |      |
| R <sub>θJA</sub>              | Junction-to-ambient thermal resistance       | 39.6       | 99.1       | °C/W |
| R <sub>θJC(top)</sub>         | Junction-to-case (top) thermal resistance    | 27.3       | 23.4       | °C/W |
| R <sub>θJB</sub>              | Junction-to-board thermal resistance         | 9.0        | 42.8       | °C/W |
| ψ <sub>JT</sub>               | Junction-to-top characterization parameter   | 0.3        | 0.9        | °C/W |
| ψ <sub>JB</sub>               | Junction-to-board characterization parameter | 8.9        | 42.0       | °C/W |
| R <sub>θJC(bot)</sub>         | Junction-to-case (bottom) thermal resistance | 6.5        | N/A        | °C/W |

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## 7.5 Electrical Characteristics

All minimum/maximum specifications at  $T_A = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ ,  $2.7\text{ V} \leq V_{DD} \leq 5.5\text{ V}$ ,  $2.5\text{ V} \leq \text{REFIN}^{(1)} \leq V_{DD}$ ,  $R_{\text{load}} = 5\text{ k}\Omega$  to GND,  $C_{\text{load}} = 200\text{ pF}$  to GND (unless otherwise noted), Digital inputs held at 0 V

| PARAMETER                               |                                                | TEST CONDITIONS                                                              | MIN | TYP         | MAX        | UNIT                           |
|-----------------------------------------|------------------------------------------------|------------------------------------------------------------------------------|-----|-------------|------------|--------------------------------|
| <b>STATIC PERFORMANCE<sup>(2)</sup></b> |                                                |                                                                              |     |             |            |                                |
| Resolution                              |                                                | DAC80004                                                                     | 16  |             |            | Bits                           |
|                                         |                                                | DAC70004                                                                     | 14  |             |            |                                |
|                                         |                                                | DAC60004                                                                     | 12  |             |            |                                |
| INL                                     | Relative accuracy <sup>(3)</sup>               |                                                                              |     |             | $\pm 1$    | LSB                            |
| DNL                                     | Differential nonlinearity <sup>(3)</sup>       | Ensured monotonic                                                            |     |             | $\pm 1$    | LSB                            |
| TUE                                     | Total unadjusted error <sup>(3)</sup>          | $T_A = +20^{\circ}\text{C}$ to $+40^{\circ}\text{C}$                         |     |             | 1.5        | mV                             |
|                                         |                                                | $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$                        |     |             | 2          |                                |
| ZCE                                     | Zero code error                                | $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$ , Code 0d into DAC     |     | $\pm 0.2$   | $\pm 2$    | mV                             |
|                                         |                                                | $T_A = +25^{\circ}\text{C}$ , Code 0d into DAC                               |     | $\pm 0.1$   |            |                                |
| ZCE-TC                                  | Zero code error TC                             | $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$                        |     | $\pm 5$     |            | $\mu\text{V}/^{\circ}\text{C}$ |
| OE                                      | Offset error <sup>(3)</sup>                    | $T_A = +20^{\circ}\text{C}$ to $+40^{\circ}\text{C}$                         |     |             | $\pm 1.2$  | mV                             |
|                                         |                                                | $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$                        |     | $\pm 0.2$   | $\pm 1.8$  |                                |
|                                         |                                                | $T_A = +25^{\circ}\text{C}$                                                  |     | $\pm 0.2$   |            |                                |
| OE-TC                                   | Offset error drift                             | $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$                        |     | $\pm 4$     |            | $\mu\text{V}/^{\circ}\text{C}$ |
| FSE                                     | Full-scale error <sup>(4)</sup>                | $T_A = +20^{\circ}\text{C}$ to $+40^{\circ}\text{C}$ , Code 65535d into DAC  |     |             | $\pm 0.05$ | %FSR                           |
|                                         |                                                | $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$ , Code 65535d into DAC |     | $\pm 0.01$  | $\pm 0.07$ | %FSR                           |
|                                         |                                                | $T_A = +25^{\circ}\text{C}$                                                  |     | $\pm 0.01$  |            |                                |
| FSE-TC                                  | Full-scale error drift <sup>(4)</sup>          | $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$                        |     | $\pm 2$     |            | ppm FSR/ $^{\circ}\text{C}$    |
| GE                                      | Gain error <sup>(3)</sup>                      | $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$                        |     | $\pm 0.005$ | $\pm 0.05$ | %FSR                           |
|                                         |                                                | $T_A = +25^{\circ}\text{C}$                                                  |     | $\pm 0.005$ |            |                                |
| GE-TC                                   | Gain drift                                     | $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$                        |     | $\pm 2$     |            | ppm FSR/ $^{\circ}\text{C}$    |
| Output voltage drift vs.Time            |                                                | $T_A = +25^{\circ}\text{C}$ , $V_{\text{out}} = 3/4$ of full scale, 1900 hr  |     | 20          |            | ppm FSR                        |
| Load Regulation                         |                                                | $T_A = +25^{\circ}\text{C}$ , $V_{\text{out}} = \text{Mid Scale}$            |     | 0.003%      |            |                                |
| PSRR                                    | DC Power supply rejection ratio <sup>(4)</sup> | $T_A = +25^{\circ}\text{C}$ , $V_{\text{out}} = \text{full scale}$           |     | -92         |            | dB                             |

(1) 200 mV headroom is required between REFIN and VDD when  $2.7\text{ V} \leq V_{DD} \leq 4.5\text{ V}$ .

(2) Output unloaded

(3) End point fit between codes Code 512 to Code 65,024 - DAC80004, Code 128 to Code 16,256 - DAC70004, Code 32 to Code 4064 - DAC60004, Output unloaded.

(4) With 100 mV headroom between DAC output and VDD.

## Electrical Characteristics (continued)

All minimum/maximum specifications at  $T_A = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ ,  $2.7\text{ V} \leq V_{DD} \leq 5.5\text{ V}$ ,  $2.5\text{ V} \leq \text{REFIN}^{(1)} \leq V_{DD}$ ,  $R_{\text{load}} = 5\text{ k}\Omega$  to GND,  $C_{\text{load}} = 200\text{ pF}$  to GND (unless otherwise noted), Digital inputs held at 0 V

| PARAMETER                     |                                          | TEST CONDITIONS                                                                                                                                                                    | MIN | TYP | MAX      | UNIT                         |
|-------------------------------|------------------------------------------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----|-----|----------|------------------------------|
| <b>DYNAMIC PERFORMANCE</b>    |                                          |                                                                                                                                                                                    |     |     |          |                              |
|                               | Output voltage settling time             | $\frac{1}{4}$ to $\frac{3}{4}$ scale and $\frac{3}{4}$ to $\frac{1}{4}$ scale settling to $\pm 1\text{ LSB}$ , $R_L = 5\text{ k}\Omega$ , $C_{\text{load}} = 200\text{ pF}$ to GND |     | 5.8 | 8        | $\mu\text{s}$                |
|                               | Slew rate                                |                                                                                                                                                                                    |     | 1.5 |          | $\text{V}/\mu\text{s}$       |
|                               | Power-up time <sup>(5)</sup>             |                                                                                                                                                                                    |     | 100 |          | $\mu\text{s}$                |
|                               | Power-on glitch energy                   | Supply slew rate $< 5\text{ V/msec}$                                                                                                                                               |     | 8   |          | mV                           |
|                               | Power-off glitch energy                  | DAC in power down mode (1 k $\Omega$ -GND), Supply slew rate $< 5\text{ V/msec}$                                                                                                   |     | 7   |          | mV                           |
|                               | Output noise                             | 0.1 Hz to 10 Hz                                                                                                                                                                    |     | 5   |          | $\mu\text{Vpp}$              |
|                               |                                          | 100 kHz BW                                                                                                                                                                         |     | 100 |          | $\mu\text{VRMS}$             |
|                               | Output noise density                     | Measured at 1 kHz                                                                                                                                                                  |     | 60  |          | $\text{nV}/\sqrt{\text{Hz}}$ |
|                               |                                          | Measured at 10 kHz                                                                                                                                                                 |     | 55  |          |                              |
| THD                           | Total harmonic distortion                | $\text{REFIN} = 3\text{ V} \pm 0.2\text{ V}_{\text{pp}}$ , Frequency = 10 kHz, DAC at mid scale, specified by design                                                               |     | -80 |          | dB                           |
| PSRR                          | AC power supply rejection ratio          | 200 mV 50 Hz and 60 Hz sine wave superimposed on power supply voltage (AC analysis)                                                                                                |     | -90 |          | dB                           |
|                               | Code change glitch impulse               | 1 LSB change around major carry, Software LDAC mode                                                                                                                                |     | 1   |          | nV-s                         |
|                               | Channel-to-channel AC (analog) crosstalk | Full-scale swing on adjacent channel, Hardware LDAC mode                                                                                                                           |     | 1   |          | nV-s                         |
|                               | Channel-to-channel DC crosstalk          | Full-scale swing on adjacent channels, Measured channel at zero scale                                                                                                              |     | 1   |          | LSB                          |
|                               |                                          | Full-scale swing on all channel, Measured channel at zero scale                                                                                                                    |     | 1   |          |                              |
|                               | Digital crosstalk                        | DAC code mid scale, Adjacent input buffer change from 0000h to FFFFh or vice versa                                                                                                 |     | 0.2 |          | nV-S                         |
|                               | Reference feedthrough                    | $\text{REFIN} = 3\text{ V} \pm 0.86\text{ V}_{\text{pp}}$ , Frequency = 100 Hz to 100 kHz, DAC at zero scale                                                                       |     | -85 |          | dB                           |
|                               | Digital feedthrough                      | At SCLK = 1 MHz, DAC output static at mid scale                                                                                                                                    |     | 0.2 |          | nV-s                         |
| <b>OUTPUT CHARACTERISTICS</b> |                                          |                                                                                                                                                                                    |     |     |          |                              |
|                               | Voltage range                            |                                                                                                                                                                                    | 0   |     | $V_{DD}$ | V                            |
|                               | Headroom                                 | Output loaded 5 k $\Omega$ , DAC code FFFFh                                                                                                                                        |     | 0.1 |          | V                            |
|                               |                                          | Output loaded 0.5 k $\Omega$ , DAC code FFFFh                                                                                                                                      |     | 10  |          | %FSR                         |
| RL                            | Resistive load                           |                                                                                                                                                                                    | 0.5 |     |          | k $\Omega$                   |
| CL                            | Capacitive load                          | $R_L = \infty$                                                                                                                                                                     |     | 1   |          | nF                           |
|                               |                                          | $R_L = 5\text{ k}\Omega$                                                                                                                                                           |     | 2   |          |                              |
| RO                            | DC output impedance                      | Normal mode                                                                                                                                                                        |     | 0.5 |          | $\Omega$                     |
|                               |                                          | Power down with 100 k $\Omega$ network                                                                                                                                             |     | 100 |          | k $\Omega$                   |
|                               |                                          | Power down with 1 k $\Omega$ network                                                                                                                                               |     | 1   |          | k $\Omega$                   |
|                               | Short circuit current                    |                                                                                                                                                                                    |     | 36  |          | mA                           |

(5) Time to exit power-down mode into normal mode. Measured from 32nd falling edge SCLK to 90% of DAC final value, Characterized at mid scale.

## Electrical Characteristics (continued)

All minimum/maximum specifications at  $T_A = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ ,  $2.7\text{ V} \leq V_{DD} \leq 5.5\text{ V}$ ,  $2.5\text{ V} \leq \text{REFIN}^{(1)} \leq V_{DD}$ ,  $R_{\text{load}} = 5\text{ k}\Omega$  to GND,  $C_{\text{load}} = 200\text{ pF}$  to GND (unless otherwise noted), Digital inputs held at 0 V

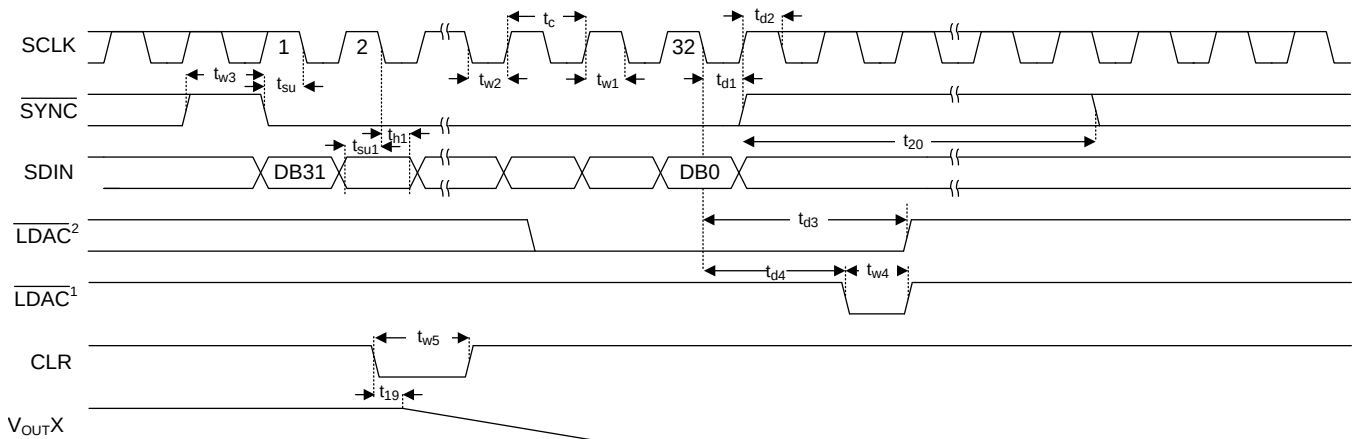
| PARAMETER                        |                           | TEST CONDITIONS                                                         | MIN          | TYP            | MAX     | UNIT               |
|----------------------------------|---------------------------|-------------------------------------------------------------------------|--------------|----------------|---------|--------------------|
| <b>VOLTAGE REFERENCE INPUT</b>   |                           |                                                                         |              |                |         |                    |
| Reference input range            |                           | $2.7\text{ V} \leq V_{DD} \leq 4.5\text{ V}$                            | 2.2          | $V_{DD} - 0.2$ |         | V                  |
|                                  |                           | $4.5\text{ V} \leq V_{DD} \leq 5.5\text{ V}$                            | 2.2          | $V_{DD}$       |         |                    |
| Reference input current          |                           |                                                                         |              |                | 450     | $\mu\text{A}$      |
| Reference input impedance        |                           |                                                                         |              | 15             |         | $\text{k}\Omega$   |
| Reference input capacitance      |                           |                                                                         |              | 10             |         | pF                 |
| MBW                              | Multiplying bandwidth     |                                                                         |              | 340            |         | kHz                |
| <b>DIGITAL INPUTS</b>            |                           |                                                                         |              |                |         |                    |
| $V_{IH}$                         | High-level input voltage  |                                                                         | 2.3          |                |         | V                  |
| $V_{IL}$                         | Low-level input voltage   |                                                                         |              |                | 0.7     | V                  |
| Input leakage                    |                           | $0 < V_{\text{DIGITAL INPUT}} < V_{DD}$                                 |              |                | $\pm 1$ | $\mu\text{A}$      |
| Pin capacitance                  |                           |                                                                         |              | 4              |         | pF                 |
| <b>DIGITAL OUTPUTS</b>           |                           |                                                                         |              |                |         |                    |
| $V_{OH}$                         | High-level output voltage | $I_{OH} = 2\text{ mA}$                                                  | $V_{DD} - 1$ |                |         | V                  |
| $V_{OL}$                         | Low-level output voltage  | $I_{OL} = 2\text{ mA}$                                                  |              |                | 0.7     | V                  |
| Pin capacitance                  |                           |                                                                         |              | 7              |         | pF                 |
| <b>POWER SUPPLY REQUIREMENTS</b> |                           |                                                                         |              |                |         |                    |
| $V_{DD}$                         | Supply voltage            |                                                                         | 2.7          |                | 5.5     | V                  |
| $I_{VDD}$                        | Supply current            | $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$ , Normal mode     |              | 4              | 5.5     | mA                 |
|                                  |                           | $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$ , Power-down mode |              | 3              | 7       | $\mu\text{A}$      |
|                                  | Power dissipation         | $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$ , Normal mode     |              | 20             |         | mW                 |
| <b>TEMPERATURE RANGE</b>         |                           |                                                                         |              |                |         |                    |
| $T_A$                            | Specified performance     |                                                                         | -40          |                | 125     | $^{\circ}\text{C}$ |

## 7.6 DACx0004 Timing Requirements

At  $T_A = -40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ ,  $T_{\text{rise}} = T_{\text{fall}} = 1 \text{ nV/sec}$  (10% to 90% of  $V_{\text{DD}}$ ) and timed from a voltage level of  $(V_{\text{IL}} + V_{\text{IH}})/2$ , SDO pin loaded with 10 pF

|                       |                                                                                                                     | 4.5 V ≤ V <sub>DD</sub> ≤ 5.5 V |     |     | 2.7 V ≤ V <sub>DD</sub> ≤ 4.5 V |     |     | UNIT |
|-----------------------|---------------------------------------------------------------------------------------------------------------------|---------------------------------|-----|-----|---------------------------------|-----|-----|------|
|                       |                                                                                                                     | MIN                             | TYP | MAX | MIN                             | TYP | MAX |      |
| SERIAL WRITE and READ |                                                                                                                     |                                 |     |     |                                 |     |     |      |
| t <sub>c</sub>        | SCLK cycle time                                                                                                     | 20                              |     |     | 40                              |     |     | ns   |
| t <sub>w1</sub>       | SCLK high pulse duration                                                                                            | 10                              |     |     | 20                              |     |     | ns   |
| t <sub>w2</sub>       | SCLK low pulse duration                                                                                             | 10                              |     |     | 20                              |     |     | ns   |
| t <sub>su</sub>       | $\overline{\text{SYNC}}$ to SCLK falling edge setup time                                                            | 15                              |     |     | 30                              |     |     | ns   |
| t <sub>su1</sub>      | Data setup time                                                                                                     | 5                               |     |     | 10                              |     |     | ns   |
| t <sub>h1</sub>       | Data hold time                                                                                                      | 5                               |     |     | 10                              |     |     | ns   |
| t <sub>d1</sub>       | SCLK falling edge to $\overline{\text{SYNC}}$ rising edge delay time                                                | 5                               |     |     | 10                              |     |     | ns   |
| t <sub>w3</sub>       | Minimum $\overline{\text{SYNC}}$ high pulse duration <sup>(1)</sup>                                                 | 25                              |     |     | 35                              |     |     | ns   |
| t <sub>d2</sub>       | $\overline{\text{SYNC}}$ rising edge to SCLK fall ignore delay time                                                 | 15                              |     |     | 20                              |     |     | ns   |
| t <sub>w4</sub>       | $\overline{\text{LDAC}}$ pulse duration low                                                                         | 20                              |     |     | 30                              |     |     | ns   |
| t <sub>d3</sub>       | SCLK falling edge to $\overline{\text{LDAC}}$ rising edge delay time                                                | 10                              |     |     | 20                              |     |     | ns   |
| t <sub>w5</sub>       | $\overline{\text{CLR}}$ minimum pulse duration low                                                                  | 10                              |     |     | 20                              |     |     | ns   |
| t <sub>d4</sub>       | SCLK falling edge to $\overline{\text{LDAC}}$ falling edge delay time                                               | 10                              |     |     | 20                              |     |     | ns   |
| t <sub>v</sub>        | SCLK rising edge to SDO valid time                                                                                  | 18                              |     |     | 18                              |     |     | ns   |
| t <sub>d5</sub>       | SCLK falling edge to $\overline{\text{SYNC}}$ rising edge delay time                                                | 5                               |     |     | 10                              |     |     | ns   |
| t <sub>d6</sub>       | $\overline{\text{SYNC}}$ rising edge to SCLK rising edge delay time                                                 | 5                               |     |     | 10                              |     |     | ns   |
| t <sub>d7</sub>       | $\overline{\text{SYNC}}$ rising edge to $\overline{\text{LDAC}}$ or $\overline{\text{CLR}}$ falling edge delay time | 20                              |     |     | 40                              |     |     | ns   |
| t <sub>19</sub>       | $\overline{\text{CLR}}$ pulse activation time                                                                       | 20                              |     |     | 20                              |     |     | ns   |
| t <sub>20</sub>       | Successive DAC Update                                                                                               | 2.4                             |     |     | 2.4                             |     |     | μs   |

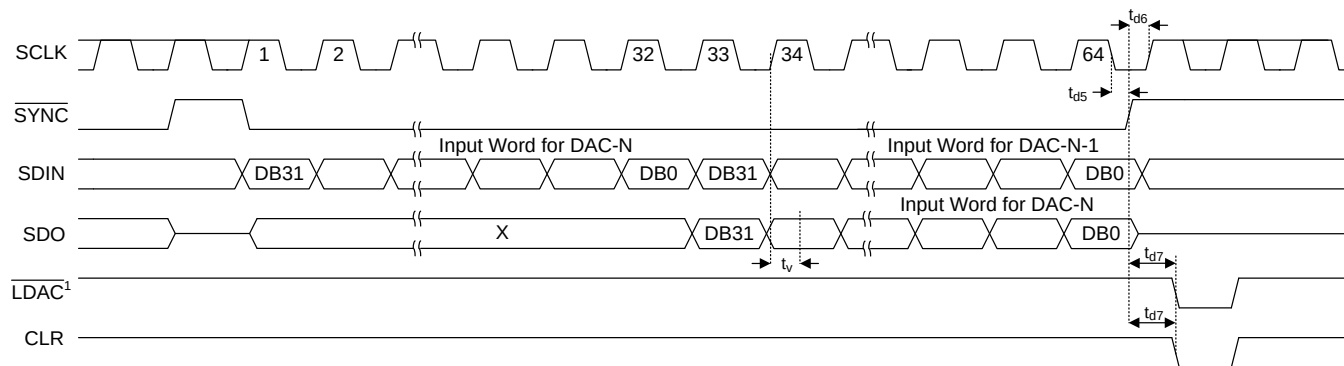
(1) Does not include output settling time



(1) Asynchronous  $\overline{\text{LDAC}}$  update

(2) Synchronous  $\overline{\text{LDAC}}$  update

**Figure 1. Stand-Alone Timing**



(1) Asynchronous  $\overline{\text{LDAC}}$  update

**Figure 2. Daisy-Chain Timing**

## 7.7 Typical Characteristics

At  $T_A = 25^\circ\text{C}$ ,  $V_{DD} = 5.5\text{ V}$ ,  $\text{REFIN} = 5.45\text{ V}$ , DAC outputs unloaded, unless otherwise noted.

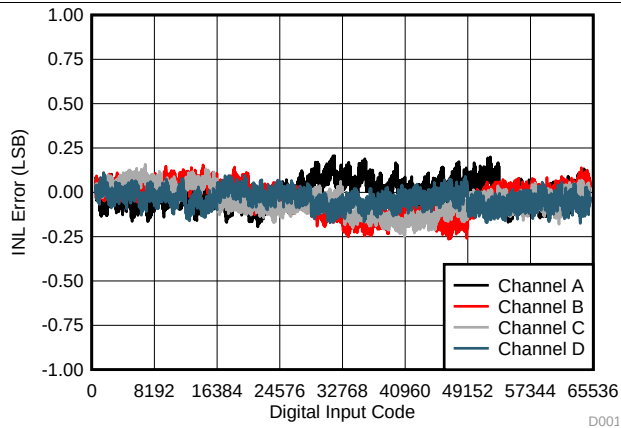


Figure 3. Linearity Error vs Digital Input Code

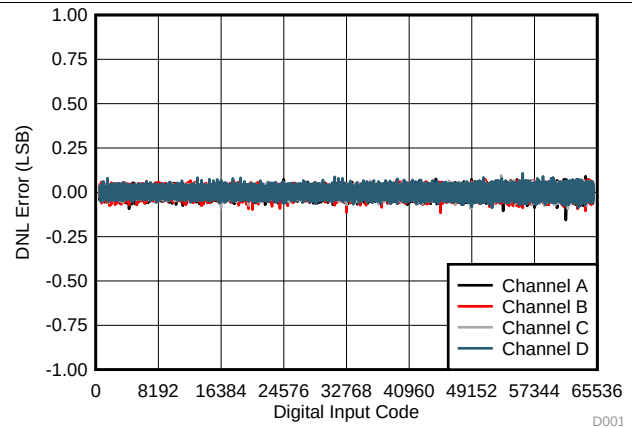
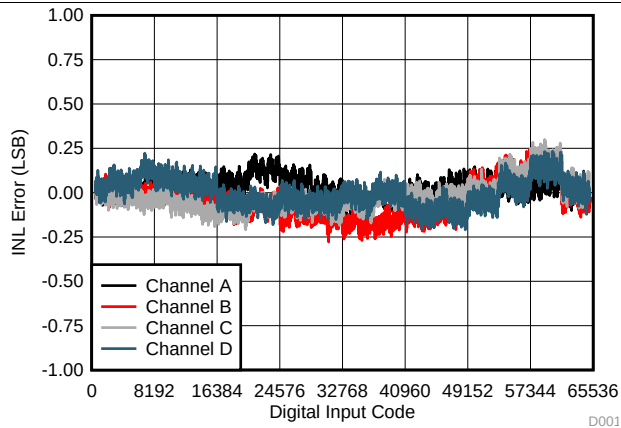
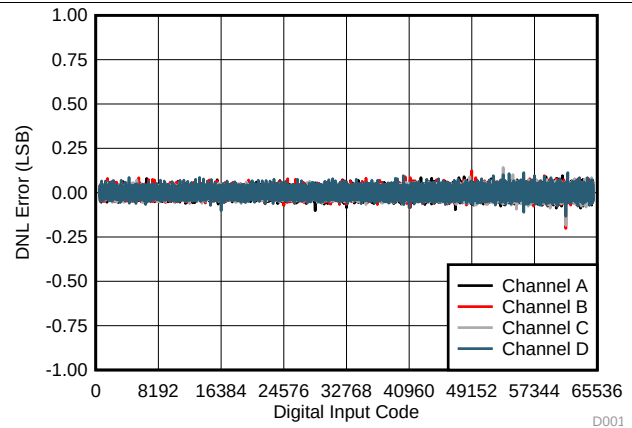


Figure 4. Differential Linearity Error vs Digital Input Code



DAC load  $5\text{ k}\Omega/200\text{ pF}$

Figure 5. Linearity Error vs Digital Input Code



DAC load  $5\text{ k}\Omega/200\text{ pF}$

Figure 6. Differential Linearity Error vs Digital Input Code

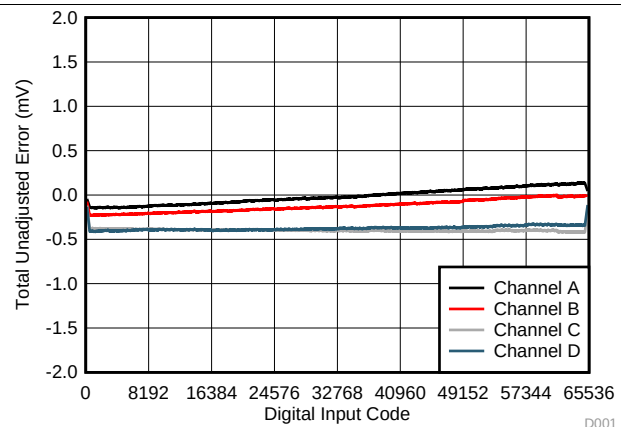
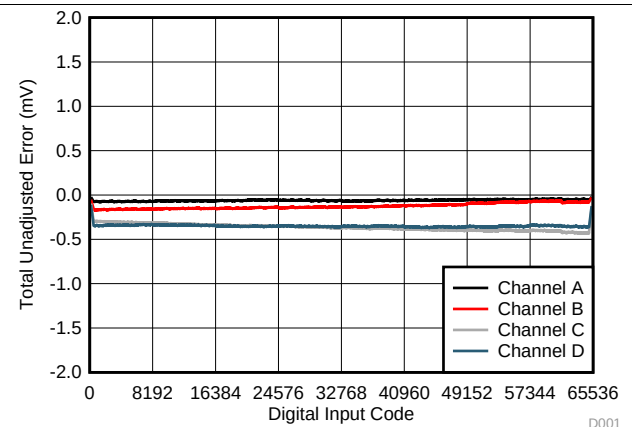


Figure 7. Total Unadjusted Error vs Digital Input Code



DAC load  $5\text{ k}\Omega/200\text{ pF}$

Figure 8. Total Unadjusted Error vs Digital Input Code

## Typical Characteristics (continued)

At  $T_A = 25^\circ\text{C}$ ,  $V_{DD} = 5.5\text{ V}$ ,  $\text{REFIN} = 5.45\text{ V}$ , DAC outputs unloaded, unless otherwise noted.

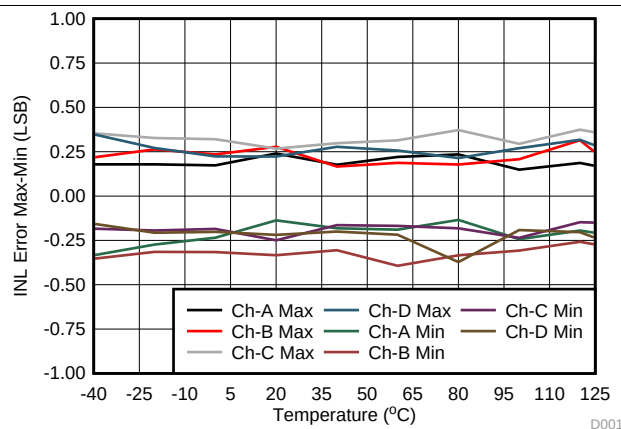


**Figure 9. Linearity Error (Max-Min) vs Temperature**

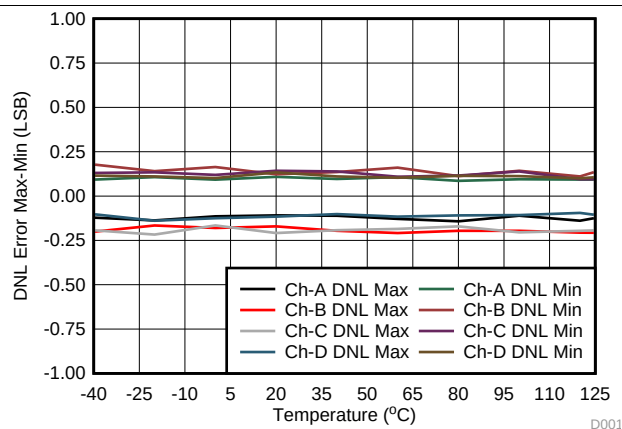


**Figure 10. Differential Linearity Error (Max-Min) vs Temperature**

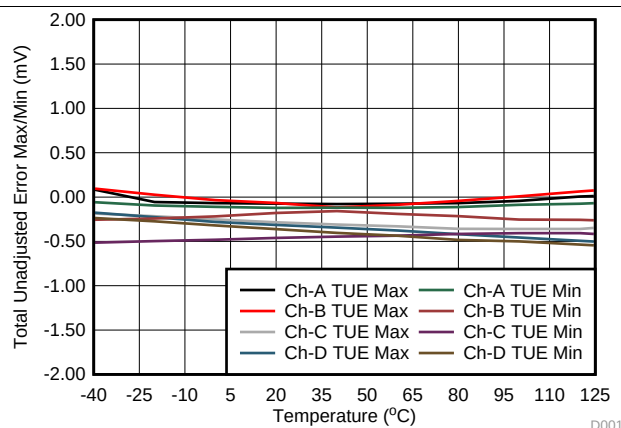


**Figure 11. Total Unadjusted Error Max/Min vs Temperature**

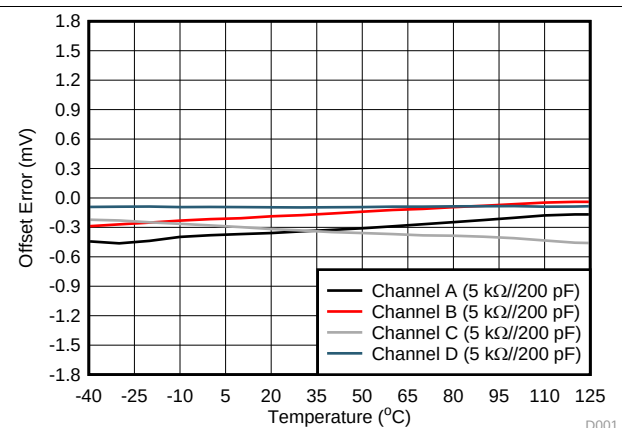


**Figure 12. Offset Error vs Temperature**

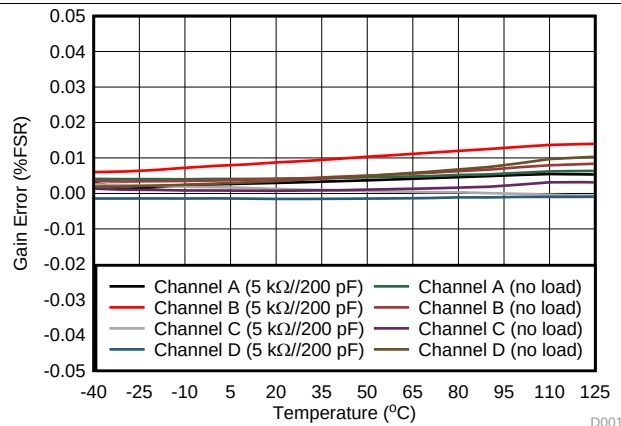


**Figure 13. Gain Error vs Temperature**

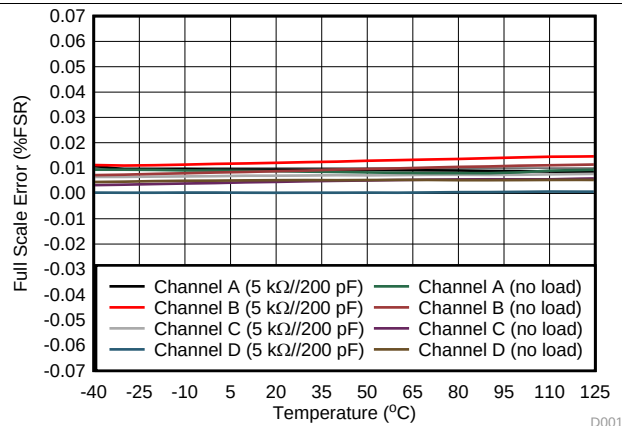


**Figure 14. Full Scale Error vs Temperature**

## Typical Characteristics (continued)

At  $T_A = 25^\circ\text{C}$ ,  $V_{DD} = 2.7\text{ V}$ ,  $\text{REFIN} = 2.5\text{ V}$ , DAC outputs unloaded, unless otherwise noted.

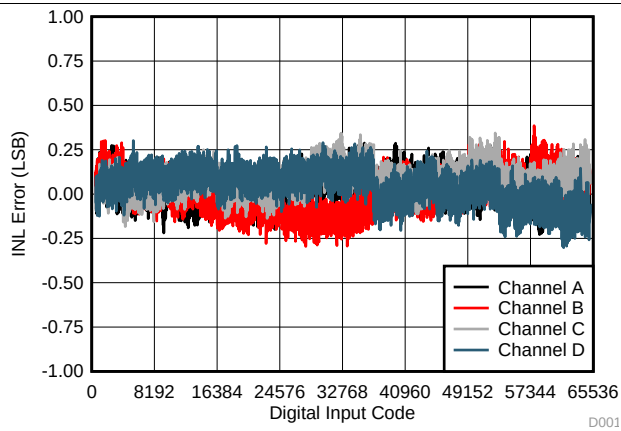


**Figure 15. Linearity Error vs Digital Input Code**

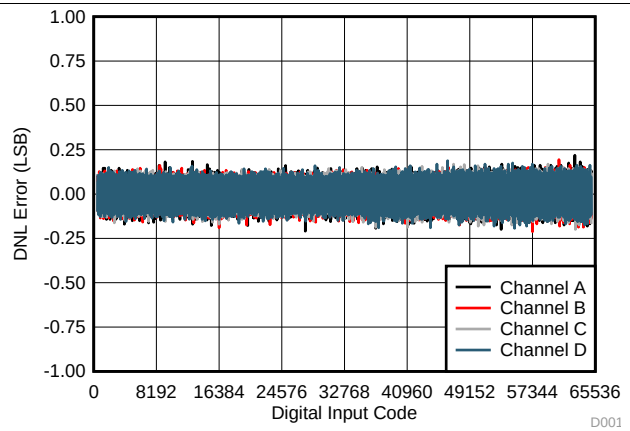
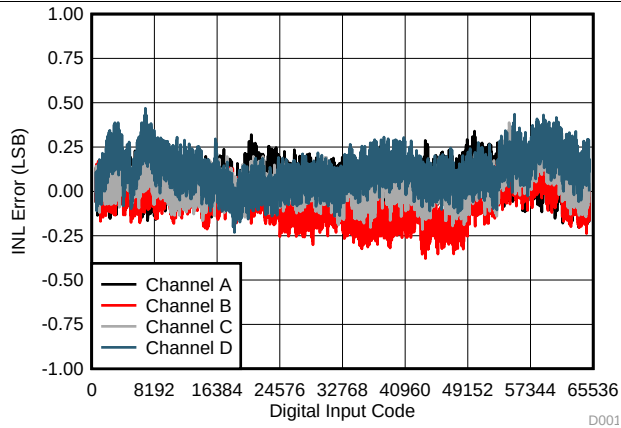
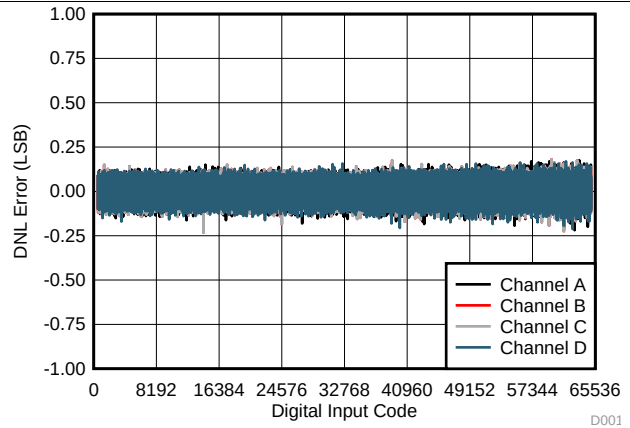


**Figure 16. Differential Linearity Error vs Digital Input Code**



DAC load  $5\text{ k}\Omega//200\text{ pF}$

**Figure 17. Linearity Error vs Digital Input Code**



DAC load  $5\text{ k}\Omega//200\text{ pF}$

**Figure 18. Differential Linearity Error vs Digital Input Code**

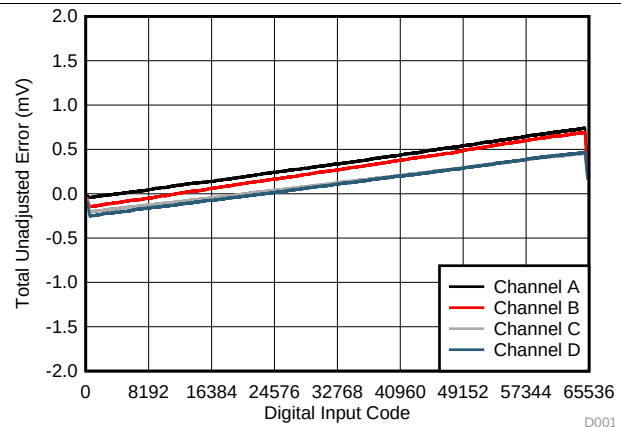
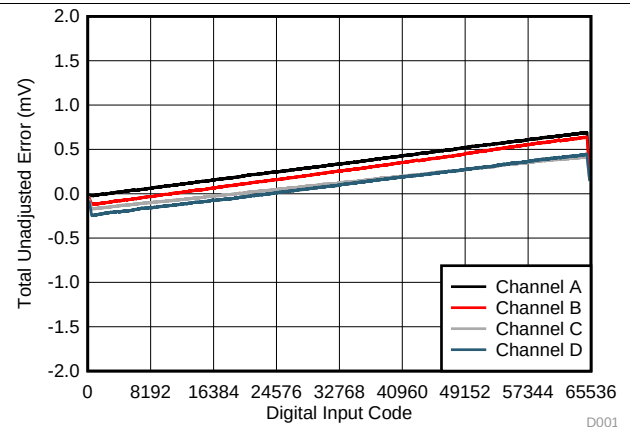


**Figure 19. Total Unadjusted Error vs Digital Input Code**



DAC load  $5\text{ k}\Omega//200\text{ pF}$

**Figure 20. Total Unadjusted Error vs Digital Input Code**

## Typical Characteristics (continued)

At  $T_A = 25^\circ\text{C}$ ,  $V_{DD} = 2.7\text{ V}$ ,  $\text{REFIN} = 2.5\text{ V}$ , DAC output unloaded, unless otherwise noted.

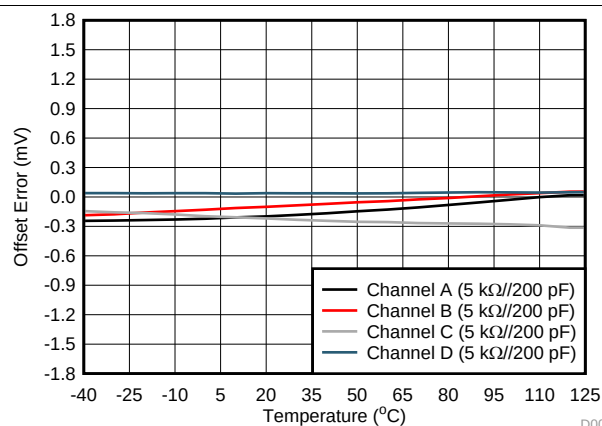


**Figure 21. Offset Error vs Temperature**

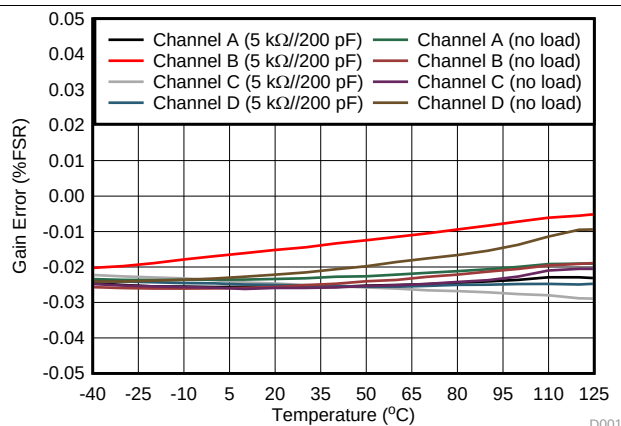


**Figure 22. Gain Error vs Temperature**

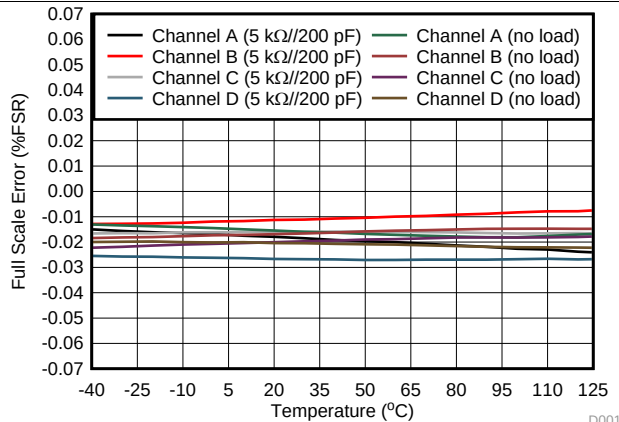
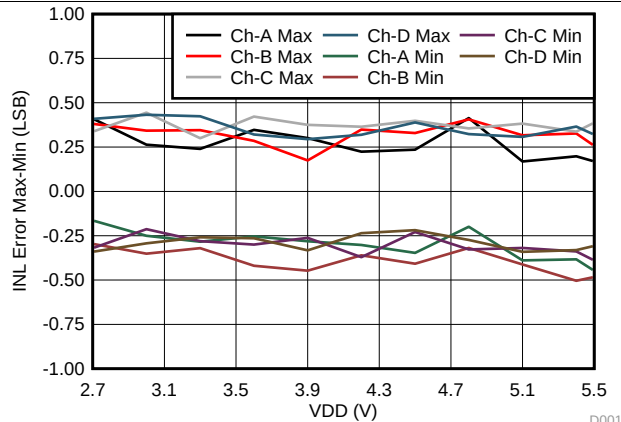
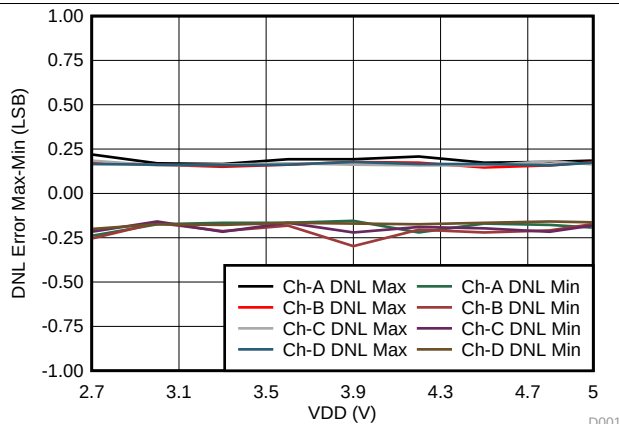


**Figure 23. Full Scale Error vs Temperature**



DAC load 5 kΩ/200 pF

**Figure 24. Linearity Error (Max-Min) vs Power Supply Voltage**



DAC load 5 kΩ/200 pF

**Figure 25. Differential Linearity Error (Max-Min) vs Power Supply Voltage**

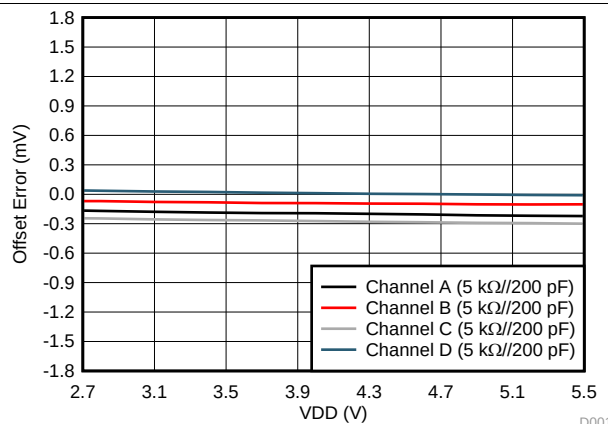


**Figure 26. Offset Error vs Power Supply Voltage**

## Typical Characteristics (continued)

At  $T_A = 25^\circ\text{C}$ ,  $V_{DD} = 5.5\text{ V}$ ,  $\text{REFIN} = 2.5\text{ V}$ , DAC output load =  $5\text{ k}\Omega \parallel 200\text{ pF}$ , unless otherwise noted.

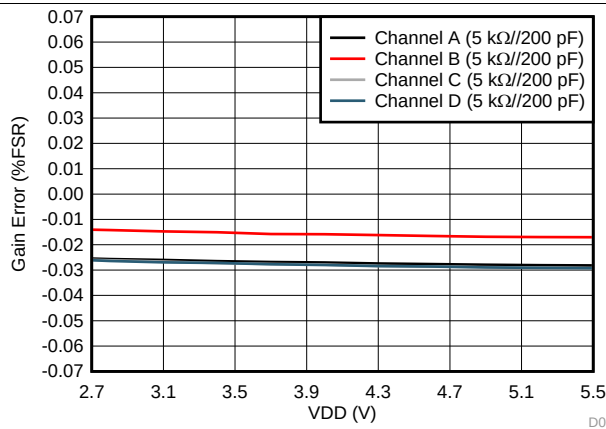


Figure 27. Gain Error vs Power Supply Voltage

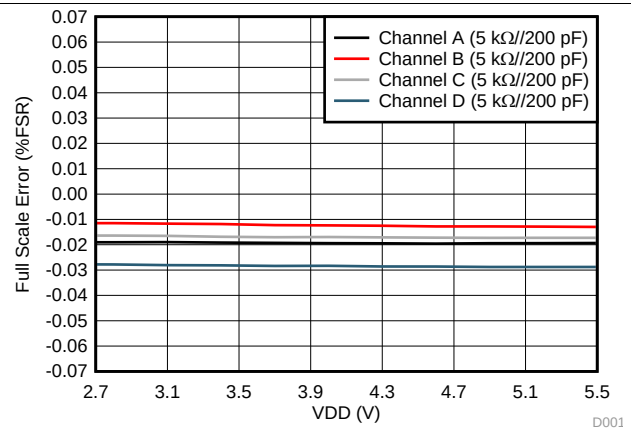


Figure 28. Full Scale Error vs Power Supply Voltage

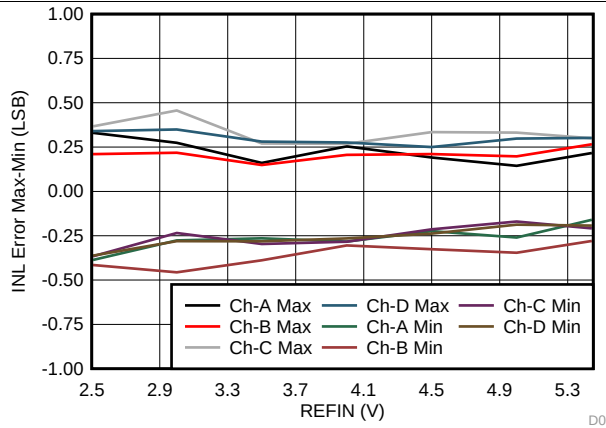


Figure 29. Linearity Error (Max-Min) vs Reference Voltage

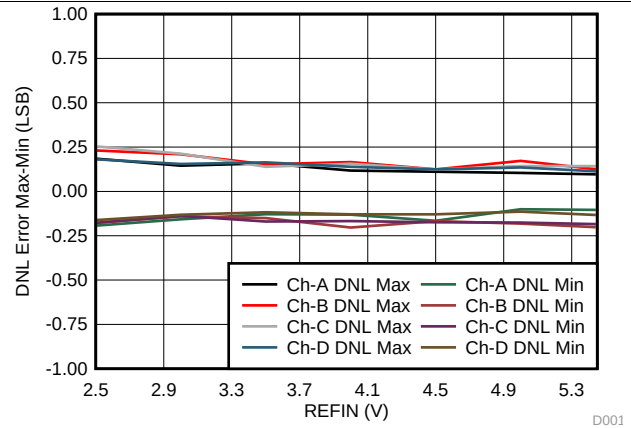


Figure 30. Differential Linearity Error (Max-Min) vs Reference Voltage

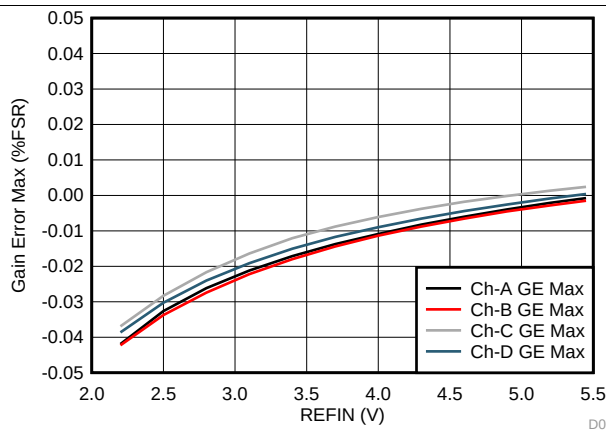


Figure 31. Gain Error (Max) vs Reference Voltage

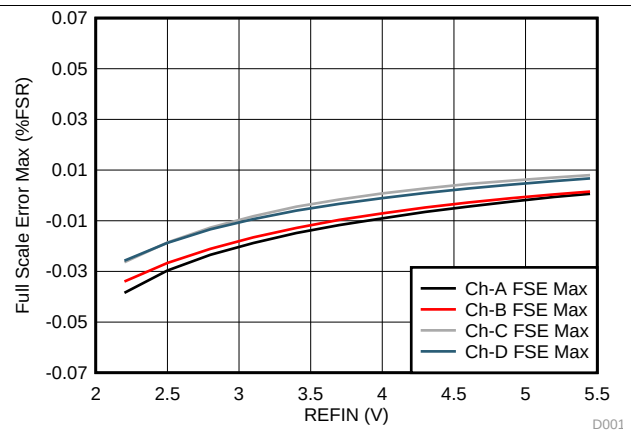


Figure 32. Full Scale Error (Max) vs Reference Voltage

## Typical Characteristics (continued)

At  $T_A = 25^\circ\text{C}$ ,  $V_{DD} = 5.5\text{ V}$ ,  $\text{REFIN} = 5.45\text{ V}$ , DAC outputs unloaded, All channels active, unless otherwise noted.

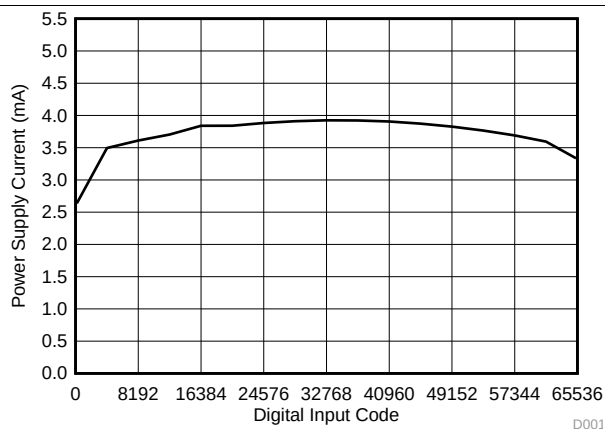
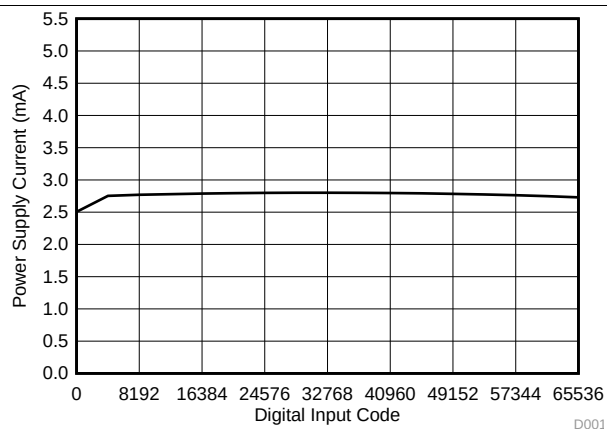
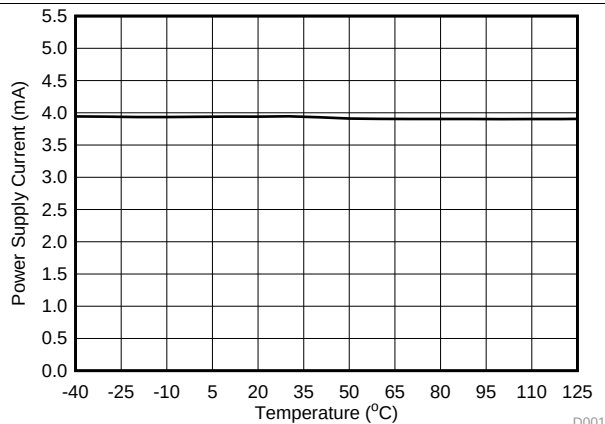


**Figure 33. Power Supply Current vs Digital Input Code**



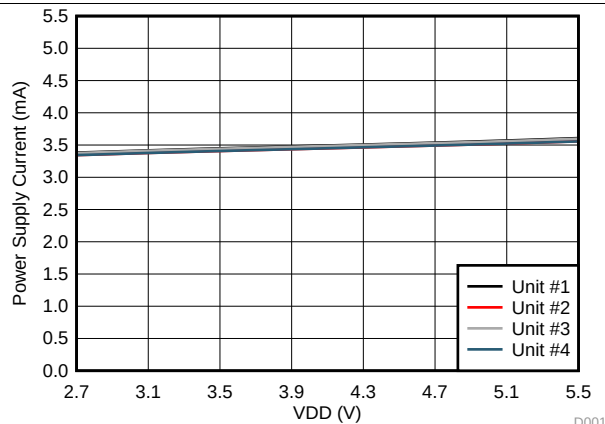
$V_{DD} = 2.7\text{ V}$ ,  $\text{REFIN} = 2.5\text{ V}$

**Figure 34. Power Supply Current vs Digital Input Code**



DAC code = mid-scale code

**Figure 35. Power Supply Current vs Temperature**



$\text{REFIN} = 2.5\text{ V}$ , DAC code = mid-scale code

**Figure 36. Power Supply Current vs Power Supply Voltage**

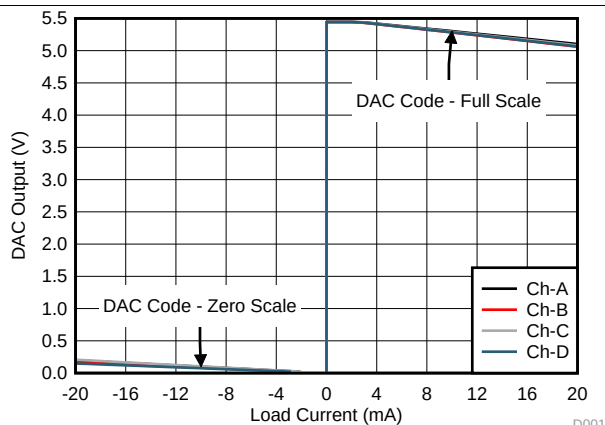
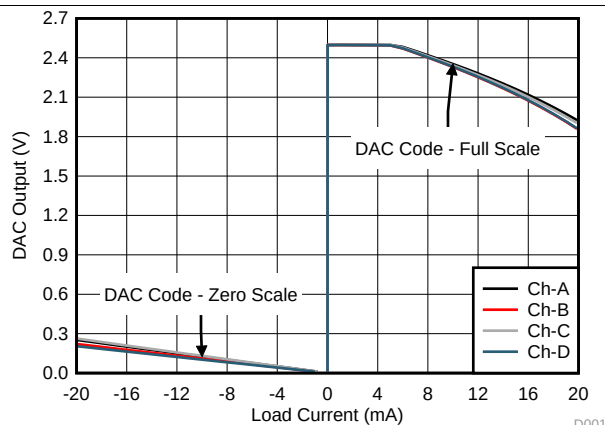


**Figure 37. DAC Output Voltage vs Load Current**



$V_{DD} = 2.7\text{ V}$ ,  $\text{REFIN} = 2.5\text{ V}$

**Figure 38. DAC Output Voltage vs Load Current**

## Typical Characteristics (continued)

At  $T_A = 25^\circ\text{C}$ ,  $V_{DD} = 5.5\text{ V}$ ,  $\text{REFIN} = 5.45\text{ V}$ , DAC output load =  $5\text{ k}\Omega \parallel 200\text{ pF}$ , unless otherwise noted.

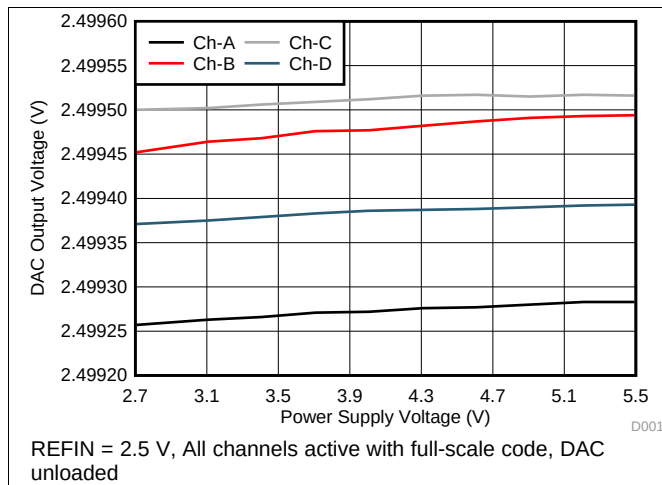


**Figure 39. DAC Output Voltage vs Power Supply Voltage**

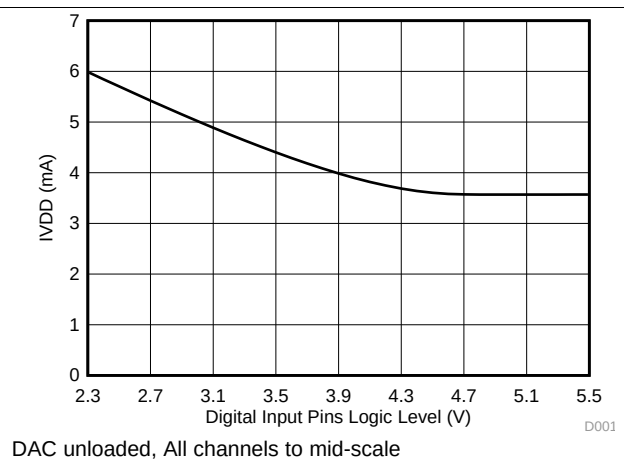


**Figure 40. Power Supply Current vs Digital Input Pins Logic Level**

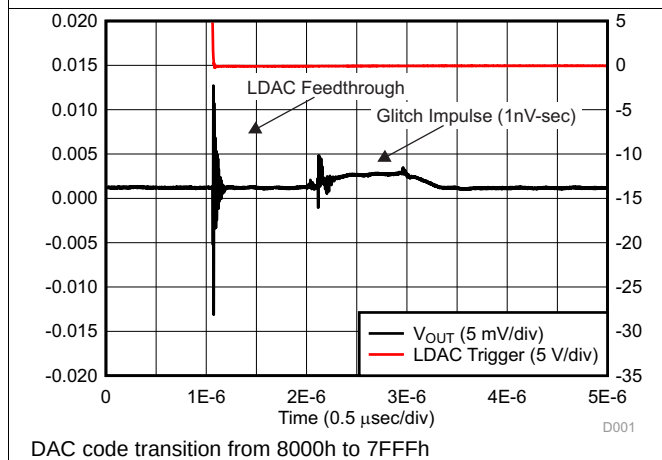


**Figure 41. Glitch Impulse, Falling Edge, 1LSB Step**

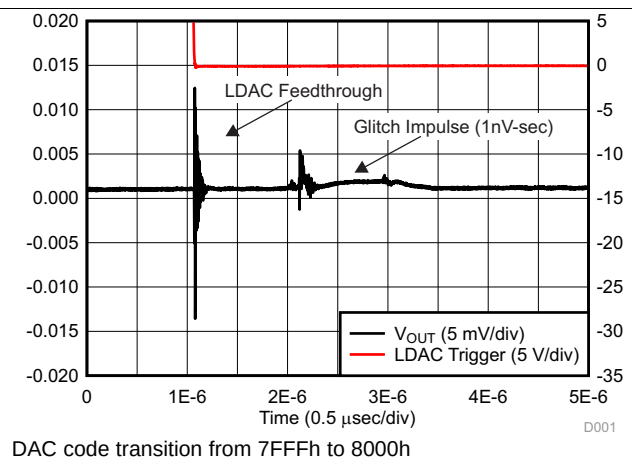


**Figure 42. Glitch Impulse, Rising Edge, 1LSB Step**

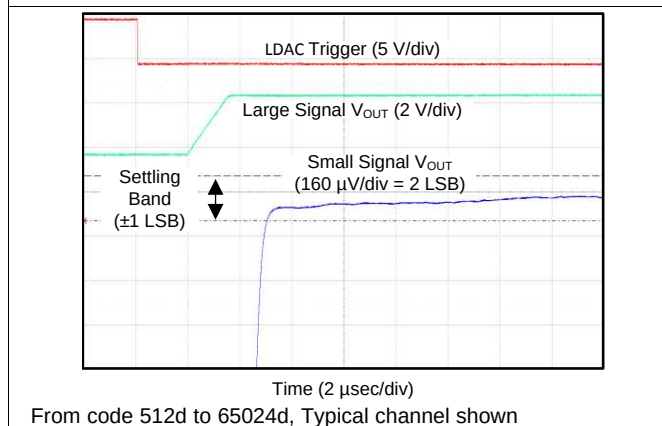


**Figure 43. Full-Scale Settling Time, Rising Edge**

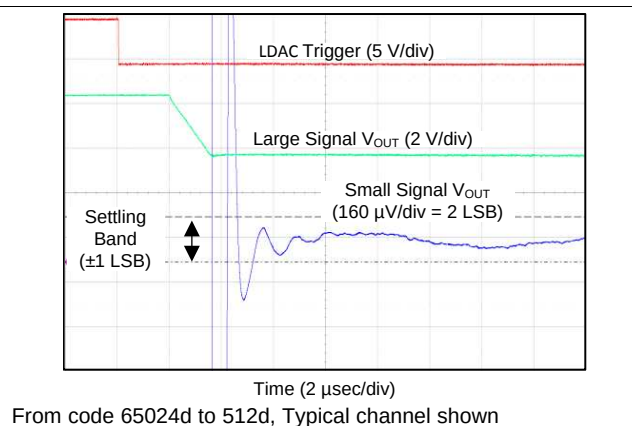
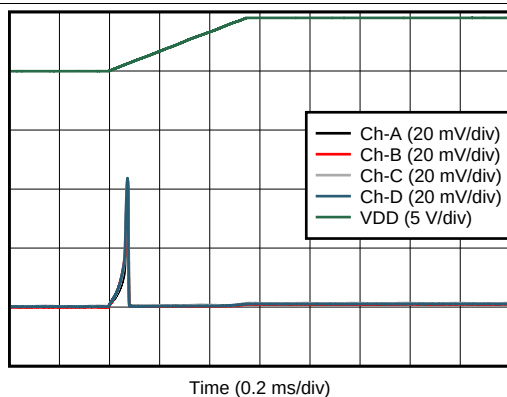


**Figure 44. Full-Scale Settling Time, Falling Edge**

## Typical Characteristics (continued)

At  $T_A = 25^\circ\text{C}$ ,  $V_{DD} = 5.5\text{ V}$ ,  $\text{REFIN} = 5.45\text{ V}$ , DAC output load =  $5\text{ k}\Omega \parallel 200\text{ pF}$ , unless otherwise noted.

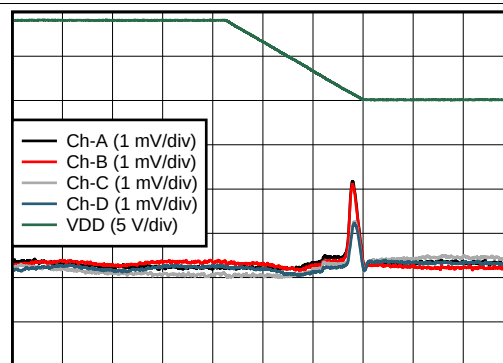


Time (0.2 ms/div)

DAC unloaded

D001

**Figure 45. Power-On Glitch, Reset to Zero Scale**

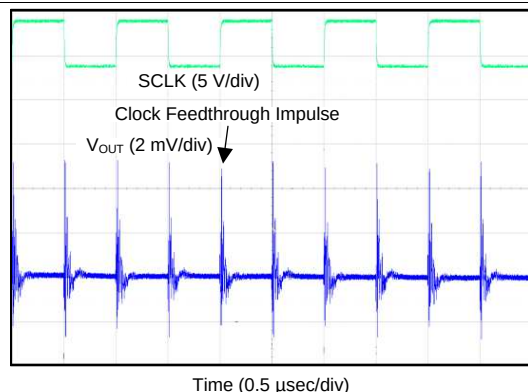


Time (2 ms/div)

DAC in power down mode ( $1\text{ k}\Omega\text{-GND}$ )

D001

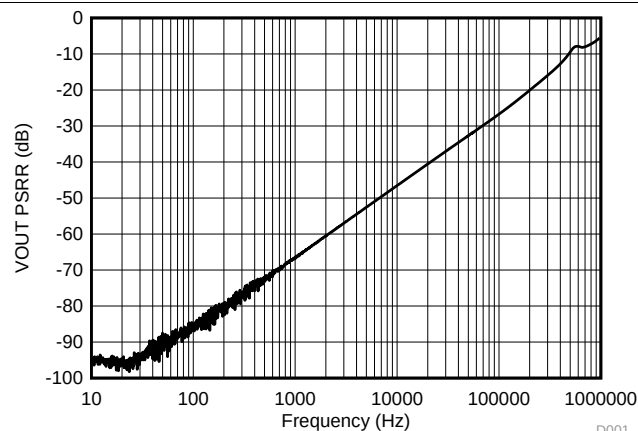
**Figure 46. Power-Off Glitch, Reset to Zero Scale**



Time (0.5 μsec/div)

DAC unloaded, DAC code mid-scale, Typical channel shown

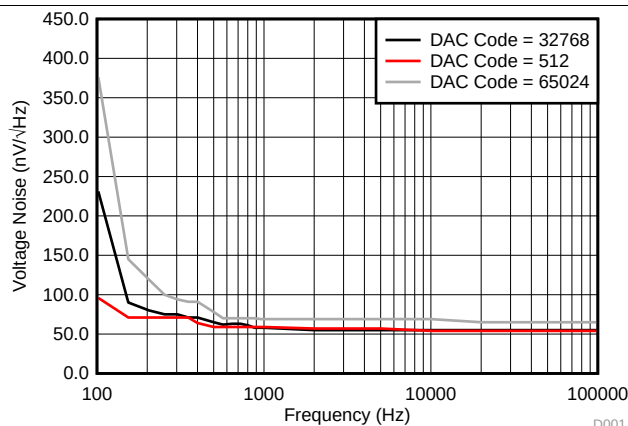
**Figure 47. Clock Feedthrough, 1MHz Midscale**



$V_{DD} = 5.0 + 1\text{ VPP}$  (Sinusoid),  $\text{REFIN} = 2.5\text{ V}$ , DAC code full-scale, Typical channel shown

D001

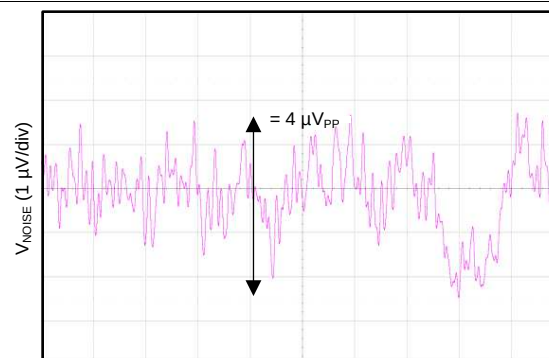
**Figure 48. DAC Output AC PSRR vs VDD**



DAC unloaded, Typical channel shown

D001

**Figure 49. DAC Output Noise Density vs Frequency**



DAC unloaded, DAC code mid-scale, Typical channel shown

**Figure 50. DAC Output Noise, 0.1 Hz to 10 Hz**

## 8 Detailed Description

### 8.1 Overview

The DAC80004, DAC70004, and DAC60004 are quad-channel, 16-bit, voltage-output DACs with internal reference buffers and output buffers. Each channel consists of an R-2R ladder configuration with the 4 MSBs segmented, followed by an operational amplifier, as shown in Figure 51. The DACx0004 devices have a constant impedance (30 kΩ typical), buffered reference input. The output of the reference buffers drives the R-2R ladders. With the production trim process these devices have excellent dc accuracy and ac performance.

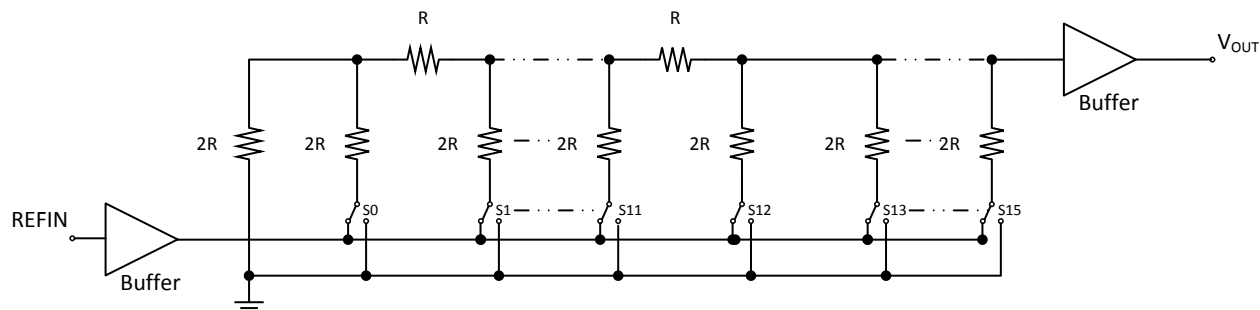


**Figure 51. DACx0004 Architecture**

The input coding to the DACx0004 is straight binary, so the ideal output voltage is given by Equation 1:

$$V_{OUT} = \left( \frac{D_{IN}}{2^N} \right) \times REF_{IN} \quad (1)$$

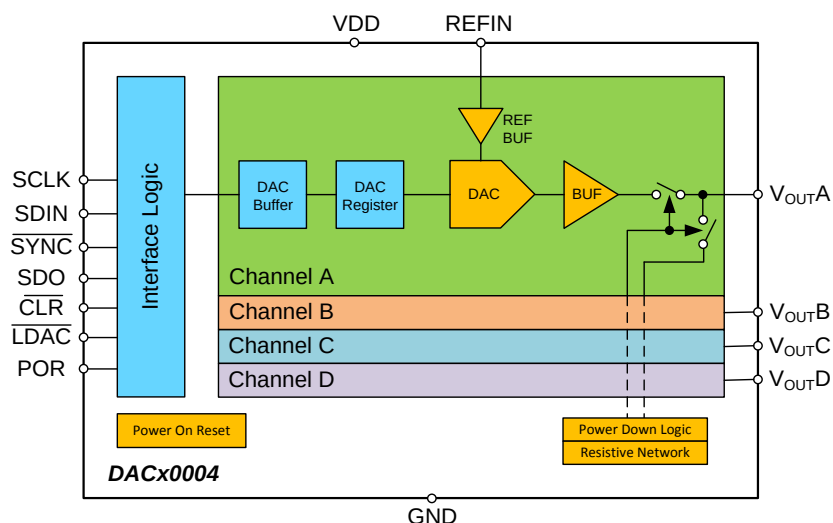
Where:

N = resolution in bits; either 16 (DAC80004), 14 (DAC70004) or 12 (DAC60004)

D<sub>IN</sub> = decimal equivalent of the binary code that is loaded to the DAC register. D<sub>IN</sub> ranges from 0 to 2<sup>N</sup> – 1

REF<sub>IN</sub> = DAC reference voltage

### 8.2 Functional Block Diagram



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## 8.3 Feature Description

### 8.3.1 Output Amplifier

The DACx0004 output buffer amplifier is capable of generating near rail-to-rail voltages on its output, giving a maximum output range of 0 V to REFIN. It is capable of driving a load of 5 k $\Omega$  in parallel with 2 nF to GND. The typical slew rate of this amplifier while driving no load is 1.5 V/ $\mu$ s, with a full-scale settling time of 8  $\mu$ s to 1 LSB of the final value as shown in [Figure 43](#) and [Figure 44](#). The current consumption of the amplifier (unloaded) is 1 mA/channel (typical). The DACx0004 output amplifier also implements a short circuit current limiting circuit. The default value of short circuit limit is 40 mA, however this can be reduced to 30 mA using dedicated bits (1 per channel) via SPI command 1010 (see [Table 2](#)).

### 8.3.2 Reference Buffer

The DACx0004 requires an external reference to operate. The reference input pin has the following input range:

$$2.2 \text{ V to } (V_{DD} - 0.2) \text{ for } 2.7 \text{ V} \leq V_{DD} \leq 4.5 \text{ V}$$

$$2.2 \text{ V to } V_{DD} \text{ for } 4.5 \text{ V} \leq V_{DD} \leq 5.5 \text{ V}$$

The DACx0004 contains a dedicated reference buffer for each DAC channel. The REFIN pin drives the input of these buffers. The integrated reference buffers offers constant impedance of 30 k $\Omega$  (typical) at the REFIN pin. This simplifies the external reference drive circuit for the device.

### 8.3.3 Power-On Reset

The DACx0004 contain a power-on-reset circuit that controls the output voltage during power up. The power-on reset is useful in applications where it is important to know the state of the output of each DAC while the device is in the process of powering up. At power up all DAC registers are filled with power-on reset code (see [Table 1](#)).

#### 8.3.3.1 POR Pin Feature

The DAC power-on reset code for all of the channels depends on the state of the POR pin at power up (see [Pin Configuration and Functions](#)).

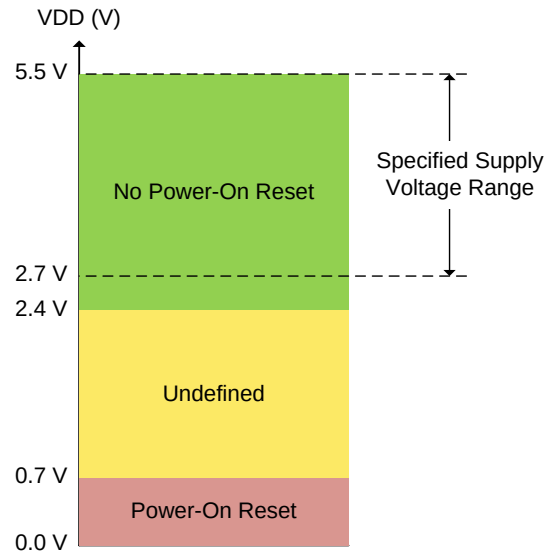
Each DAC channel remains that way until a valid load command is written to it. All device registers are reset at power up as shown in [Table 1](#).

**Table 1. DACx0004 Power-On Reset Values**

| REGISTER NAME                     | DACx0004 - POWER-ON RESET VALUE                                |
|-----------------------------------|----------------------------------------------------------------|
|                                   | TSSOP-/VSON-14                                                 |
| DAC latches (per channel)         | If POR pin = '0' then Zero Scale else Mid scale                |
| DAC buffers (per channel)         | If POR pin= '0' then Zero Scale else Mid scale                 |
| Power down (per channel)          | 00 – Normal mode                                               |
| Clear mode                        | 00 – Clear to Zero                                             |
| Ignore LDAC (per channel)         | 0000 – Do not ignore                                           |
| Daisy chain                       | 0 – Daisy chain disabled, DAC update at 32nd SCLK falling edge |
| Short circuit limit (per channel) | 0000 – all DACs 40 mA                                          |

#### 8.3.3.2 Internal Power-On Reset (IPOR) Levels

When the device powers up, an IPOR circuit sets the device in default mode as shown in [Table 1](#). The IPOR circuit requires specific  $V_{DD}$  levels, as indicated in [Figure 52](#), to ensure discharging of internal capacitors and to reset the device on power up. In order to ensure a power-on reset,  $V_{DD}$  must be below 0.7 V for at least 1 ms. When  $V_{DD}$  drops below 2.4 V but remains above 0.7 V (shown as the undefined region), the device may or may not reset under all specified temperature and power supply conditions. In this case, In this case a power-down reset is recommended. When  $V_{DD}$  remains above 2.4 V, a power-on reset does not occur.


**Figure 52. Relevant Voltage Levels for IPOR Circuit**

## 8.4 Device Functional Modes

### 8.4.1 Serial Interface

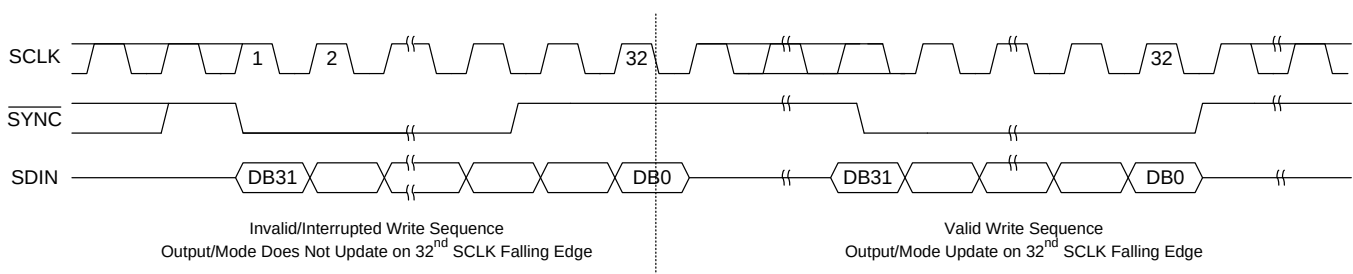
The DACx0004 devices have a 4-wire serial interface:  $\overline{\text{SYNC}}$ , SCLK, SDIN, and SDO (see [Pin Configuration and Functions](#)). The serial interface (3-wire and 4-wire) is compatible with SPI, QSPI, and Microwire interface standards, as well as most DSPs and it operates up to 50 MHz. See the Write Mode Stand-Alone Timing and Write Mode Daisy-Chain Timing diagrams (see [Figure 1](#) and [Figure 2](#)) for examples of typical write and read sequences. The input shift register is 32 bits wide.

#### 8.4.1.1 Stand-Alone Mode

The serial clock SCLK can be a continuous or a gated clock. The first falling edge of  $\overline{\text{SYNC}}$  starts the operation cycle. When  $\overline{\text{SYNC}}$  is high, the SCLK and SDIN signals are blocked and the SDO pin (TSSOP-14 and VSON-14 packages) is in a Hi-Z state. The device internal registers are updated from the shift register on the 32nd falling edge of SCLK.

##### 8.4.1.1.1 $\overline{\text{SYNC}}$ Interrupt – Stand-Alone Mode

For stand-alone operation, the  $\overline{\text{SYNC}}$  line stays low for at least 32 falling edges of SCLK and the addressed DAC register updates on the 32nd SCLK falling edge. However, if  $\overline{\text{SYNC}}$  is brought high before the 32nd SCLK falling edge, it acts as an interrupt to the write sequence; the shift register resets and the write sequence is discarded. Neither an update of the data buffer contents, DAC register contents, nor a change in the operating mode occurs (as shown in [Figure 53](#)).


**Figure 53.  $\overline{\text{SYNC}}$  Interrupt – Stand Alone Operation**

## Device Functional Modes (continued)

### 8.4.1.1.2 Read-Back Mode

The READ command is used to start read-back operation. However, before read-back operation can be initiated, the SDO pin must be enabled by setting the DSDO bit to '1'; this bit is disabled by default. Read-back operation is then started by executing a READ command (R/W bit = '1', see [Table 3](#)). Bits C3 to C0 select the register to be read. The remaining data in the command are don't care bits. During the next SPI operation, the data appearing on the SDO output are from the previously addressed register. For a read of a single register, a NOP (No Operation) command (1110) can be used to clock out the data from the selected register on SDO. Multiple registers can be read if multiple READ commands are issued (see [Figure 54](#)).

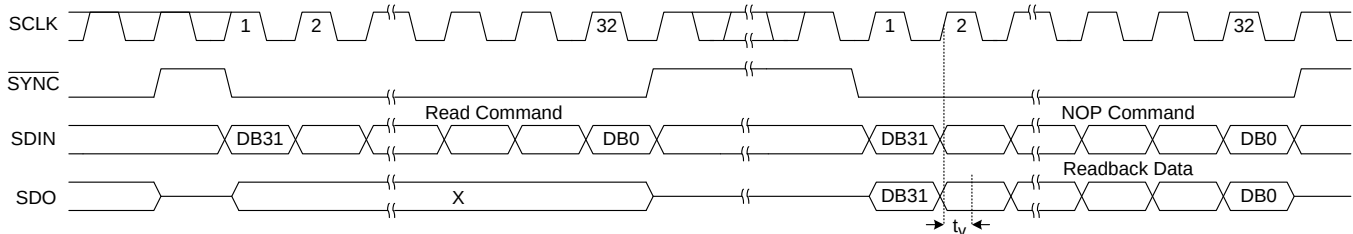


**Figure 54. Read-Back Operation**

### 8.4.1.2 Daisy-Chain Mode

For systems that contain more than one device, the SDO pin can be used to daisy-chain multiple devices together (see [Figure 55](#)). Daisy-chain operation can be useful in system diagnostics and in reducing the number of serial interface lines. The daisy-chain feature can be enabled by writing a logic '1' to the DSDO bit (see [Table 3](#)); the SDO pin is set to HIZ when the DSDO bit is set to 0.

The first falling edge of  $\overline{\text{SYNC}}$  starts the operating cycle. SCLK is continuously applied to the SPI shift register when  $\overline{\text{SYNC}}$  is low. If more than 32 clock pulses are applied, the data ripples out of the shift register and appear on the SDO line. The data bits are clocked out on the rising edge of SCLK and are valid on the falling edge. By connecting the SDO pin of the first device to the SDI input of the next device in the chain, a multiple-device interface is constructed (see [Figure 2](#)). Each device in the system requires 32 clock pulses. Therefore, the total number of clock cycles must equal  $32 \times N$ , where N is the total number of DACx0004s in the chain. When the serial transfer to all devices is complete,  $\overline{\text{SYNC}}$  is taken high. This action latches the data from the SPI shift registers to the device internal registers for each device in the daisy-chain and prevents any further data from being clocked in. The serial clock can be a continuous or a gated clock. Note that a continuous SCLK source can only be used if  $\overline{\text{SYNC}}$  is held low for the correct number of clock cycles. For gated clock mode, a burst clock containing the exact number of clock cycles must be used and  $\overline{\text{SYNC}}$  must be taken high after the final clock in order to latch the data.

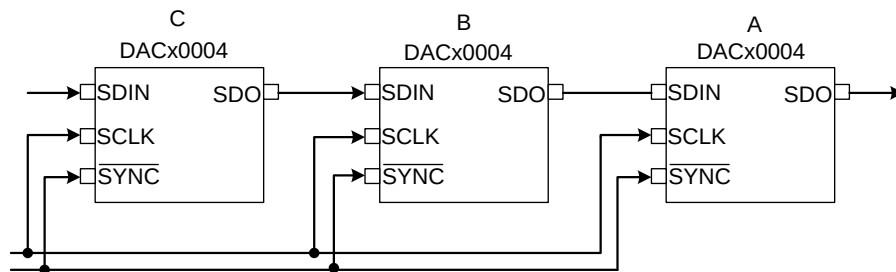


**Figure 55. DACx0004 in Daisy Chain Mode**

#### 8.4.1.2.1 $\overline{\text{SYNC}}$ Interrupt – Daisy-Chain Mode

For daisy-chain operation, the  $\overline{\text{SYNC}}$  line stays low for at least  $32 \times N$  SCLK cycles, where N is the number of DACx0004s in the daisy chain. If  $\overline{\text{SYNC}}$  is brought high before a multiple 32 SCLKs, it acts as an interrupt to the write sequence; the shift register resets and the write sequence is discarded. Neither an update of the data buffer contents, DAC register contents, nor a change in the operating mode occurs (see [Figure 56](#)).

## Device Functional Modes (continued)

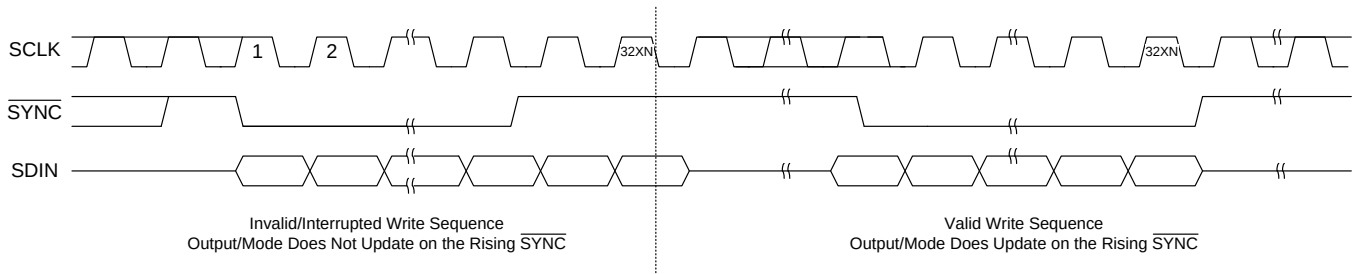


**Figure 56. SYNC Interrupt – Daisy-Chain Operation**

### 8.4.2 SPI Shift Register

The SPI shift register is 32 bits wide, as shown in Table 2. The shift register command mapping is shown in Table 3. The DACx0004 accepts DAC code in straight binary format. Note that, the DAC data is left aligned from MSB (D19) to LSB (D4 - 16 bits, D6 - 14 bits, D8 - 12 bits).

**Table 2. DACx0004 SPI Shift Register Format**

| D31         | D30 | D29 | D28 | D27-D24      | D23-D20              | D19-D04                                                             | D03-D00   |
|-------------|-----|-----|-----|--------------|----------------------|---------------------------------------------------------------------|-----------|
| Don't Cares |     |     | R/W | Command Bits | Channel Address Bits | 16/14/12-Bit DAC Data left aligned/Power Down Bits/Device Ready bit | Mode Bits |

**Table 3. DAC Commands**

| D31 - D28 |                  | D27 - D24 |   |   |   | D23 - D20       | D19 - D16 | D15 - D12 | D11 - D08 |     |     | D07 - D04 | D03 - D00 |      |       |      | Commands                                              |                     |
|-----------|------------------|-----------|---|---|---|-----------------|-----------|-----------|-----------|-----|-----|-----------|-----------|------|-------|------|-------------------------------------------------------|---------------------|
| X         | $\overline{W}/R$ | 0         | 0 | 0 | 0 | Channel Address | DAC Data  | DAC Data  | DAC Data  |     |     | DAC Data  | X         |      |       |      | Write to buffer n                                     |                     |
| X         | $\overline{W}$   | 0         | 0 | 0 | 1 | Channel Address | X         | X         | X         |     |     | X         | X         |      |       |      | Update DAC n                                          |                     |
| X         | $\overline{W}$   | 0         | 0 | 1 | 0 | Channel Address | DAC Data  | DAC Data  | DAC Data  |     |     | DAC Data  | X         |      |       |      | Write to buffer n and update all DACs (Software LDAC) |                     |
| X         | $\overline{W}$   | 0         | 0 | 1 | 1 | Channel Address | DAC Data  | DAC Data  | DAC Data  |     |     | DAC Data  | X         |      |       |      | Write to buffer and update DAC n                      |                     |
| X         | $\overline{W}/R$ | 0         | 1 | 0 | 0 | X               | X         | X         | X         | PD1 | PD0 |           |           | Ch-D | Ch-C  | Ch-B | Ch-A                                                  | Power up/down DAC n |
| X         | $\overline{W}/R$ | 0         | 1 | 0 | 1 | X               | X         | X         | X         |     |     | X         | X         | X    | CM1   | CM0  | Clear mode register                                   |                     |
| X         | $\overline{W}/R$ | 0         | 1 | 1 | 0 | X               | X         | X         | X         |     |     | X         | Ch-D      | Ch-C | Ch-B  | Ch-A | LDAC register                                         |                     |
| X         | $\overline{W}$   | 0         | 1 | 1 | 1 | X               | X         | X         | X         |     |     | X         | X         |      |       |      | Software reset                                        |                     |
| X         | $\overline{W}/R$ | 1         | 0 | 0 | 0 | X               | X         | X         | X         |     |     | X         | X         |      | DSD 0 | X    | Disable SDO register                                  |                     |
| X         | X                | 1         | 0 | 0 | 1 | X               | X         | X         | X         |     |     | X         | X         |      |       |      | Reserved                                              |                     |
| X         | $\overline{W}/R$ | 1         | 0 | 1 | 0 | X               | X         | X         | X         |     |     | X         | Ch-D      | Ch-C | Ch-B  | Ch-A | Short circuit limit register                          |                     |
| X         | $\overline{W}$   | 1         | 0 | 1 | 1 | X               | X         | X         | X         |     |     | X         | X         |      |       |      | Software clear                                        |                     |
| X         | X                | 1         | 1 | 0 | 0 | X               | X         | X         | X         |     |     | X         | X         |      |       |      | Reserved                                              |                     |
| X         | R                | 1         | 1 | 0 | 1 | X               | X         | X         | X         |     |     | X         | X         | DRDY | X     |      |                                                       | Status register     |
| X         | $\overline{W}$   | 1         | 1 | 1 | 0 | X               | X         | X         | X         |     |     | X         | X         |      |       |      | No operation (NOP)                                    |                     |
| X         | X                | 1         | 1 | 1 | 1 | X               | X         | X         | X         |     |     | X         | X         |      |       |      | Reserved                                              |                     |

**Table 4. Channel Address Bits**

| CHANNEL ADDRESS BITS |     |     |     | DESCRIPTION        |
|----------------------|-----|-----|-----|--------------------|
| D23                  | D22 | D21 | D20 |                    |
| 0                    | 0   | 0   | 0   | Select channel A   |
| 0                    | 0   | 0   | 1   | Select channel B   |
| 0                    | 0   | 1   | 0   | Select channel C   |
| 0                    | 0   | 1   | 1   | Select channel D   |
| 1                    | 1   | 1   | 1   | Select all channel |

### 8.4.3 DAC Power-Down Modes

The DACx0004 use four modes of operation. These modes are accessed by setting command bits D28 – D24 and power-down register bits D09 and D08. The command bits must be set to 0100 (see Table 3). Once the command bits are set correctly, the four different power-down modes are software programmable by setting bits D09 and D08 in the shift register. Table 5 shows how to control the operating mode with data bits PD1 (D09), PD0 (D08).

**Table 5. Power-Down Bits**

| POWER DOWN BITS |     | DESCRIPTION                                             |
|-----------------|-----|---------------------------------------------------------|
| D09             | D08 |                                                         |
| 0               | 0   | Normal operation/power up selected channel(s) (Default) |
| 0               | 1   | Power down selected channel(s) 1 kΩ-GND                 |
| 1               | 0   | Power down selected channel(s) 100 kΩ-GND               |
| 1               | 1   | Power down selected channel(s) Hi-Z                     |

It is possible to write to the DAC register/buffer of the DAC channel that is powered down. When the DAC channel is then powered up, it powers up to this new value.

The advantage of the available power-down modes is that the output impedance of the device is known while it is in power-down mode. As described in Table 5, there are three different power-down options.  $V_{OUTX}$  can be connected internally to GND through a 1 kΩ resistor, a 100 kΩ resistor, or open-circuited (Hi-Z). The DAC power-down circuitry is shown in Figure 57.

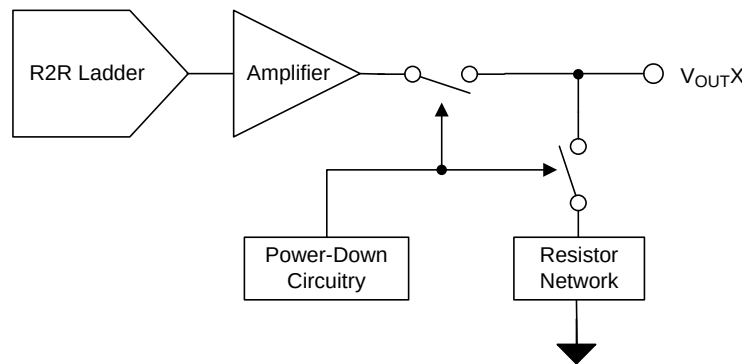


**Figure 57. DACx0004 Power Down**

### 8.4.4 CLR Pin Functionality and Software CLEAR Mode

The  $\overline{\text{CLR}}$  pin is an asynchronous input pin to the DAC. When activated, this falling edge sensitive pin clears the DAC buffers and the DAC latches to zero, mid, full or user programmed code depending on the clear mode register (see Table 6). The default setting for clear operation is clear to 0 V. The device exits clear mode on the 32nd falling edge of the next write to the device. If the  $\overline{\text{CLR}}$  pin receives a falling edge signal during a write sequence in normal operation, the clear mode is activated and changes the input and DAC registers immediately. Additionally, all DAC registers can also be cleared via SPI command 1011. Note that the clear mode bits determine the clear code for all the DACs upon clear operation.

#### 8.4.4.1 DAC Clear Mode Registers

The DACx0004 implement four different clear modes. These modes are accessed by setting command bits D28 – D24 and clear mode register bits D01 and D00. The command bits must be set to 0101 (see Table 3). Based on the value of clear mode register (see Table 6), all of the DAC and the buffers are cleared to zero, mid, or full-scale code, when the  $\overline{\text{CLR}}$  pin sees a falling edge or after a software clear command is issued.

The user defined clear scale can be set by writing 16-/14-/12- data to 1001 to bits D28 – D24.

**Table 6. Clear Mode Bits**

| CLEAR MODE BITS |     | DESCRIPTION                            |
|-----------------|-----|----------------------------------------|
| D01             | D00 |                                        |
| 0               | 0   | All DACs clear to zero scale (default) |
| 0               | 1   | All DACs clear to mid scale            |
| 1               | 0   | All DACs clear to full scale           |

#### 8.4.5 LDAC Pin Functionality

The DACx0004 devices offer both a software and hardware simultaneous update and control function. The DAC double-buffered architecture has been designed so that new data can be entered for each DAC without disturbing the analog outputs. Data updates can be performed either in synchronous or in asynchronous mode.

In asynchronous mode, the  $\overline{\text{LDAC}}$  pin is used as an active low signal for simultaneous DAC updates. Multiple single-channel writes can be done in order to set different channel buffers to desired values and then pulse the  $\overline{\text{LDAC}}$  pin low to simultaneously update the DAC output registers. Data buffers of all channels must be loaded with desired data before an  $\overline{\text{LDAC}}$  low pulse. After a  $\overline{\text{LDAC}}$  low pulse, all DACs are simultaneously updated with the last contents of the corresponding data buffers. If the content of a data buffer is not changed, the corresponding DAC output remains unchanged after the  $\overline{\text{LDAC}}$  pin is pulsed low.

In synchronous mode, data are updated with the falling edge of the 32nd SCLK cycle, which follows a falling edge of SYNC. For such synchronous updates, the  $\overline{\text{LDAC}}$  pin is not required, and it must be connected to GND permanently or asserted and held low before sending commands to the device.

##### 8.4.5.1 Software $\overline{\text{LDAC}}$ Mode Registers

Alternatively, all DAC outputs can be updated simultaneously using the built-in software function of  $\overline{\text{LDAC}}$ . The  $\overline{\text{LDAC}}$  register offers additional flexibility and control by allowing the selection of which DAC channel(s) should be updated simultaneously when the  $\overline{\text{LDAC}}$  pin is being brought low. The  $\overline{\text{LDAC}}$  register is loaded with a 4-bit word (D03 and D00) using command bits D28 – D24 (see Table 3). The default value for each bit, and therefore for each DAC channel, is zero. If the  $\overline{\text{LDAC}}$  register bit is set to 1, it overrides the  $\overline{\text{LDAC}}$  pin (the  $\overline{\text{LDAC}}$  pin is internally tied low for that particular DAC channel), and this DAC channel updates synchronously after the falling edge of the 32nd SCLK cycle. However, if the  $\overline{\text{LDAC}}$  register bit is set to 0, the DAC channel is controlled by the  $\overline{\text{LDAC}}$  pin.

See Table 7 for more information.

**Table 7.  $\overline{\text{LDAC}}$  Register**

| $\overline{\text{LDAC}}$ REGISTER BITS (D03 – D00) | DAC UPDATE                                                                                                                                 |
|----------------------------------------------------|--------------------------------------------------------------------------------------------------------------------------------------------|
| 0                                                  | Determined by $\overline{\text{LDAC}}$ pin (Default)                                                                                       |
| 1                                                  | DAC channel ignores $\overline{\text{LDAC}}$ pin, DAC updates on 32nd falling edge of SCLK, DAC channels see $\overline{\text{LDAC}}$ as 0 |

#### 8.4.6 Software Reset Mode

The DACx0004 implements a software reset feature. The software reset function uses command bits D28 – D24 (see Table 3). Table 1 shows the reset values for different registers.

### 8.4.7 Output Short Circuit Limit Register

The DACx0004 output amplifier has a default short circuit limit of 40 mA. However, this limit can be reduced to 30 mA by using command 1010 on bits D28 – D24 and selecting channel(s) (D03 – D00). Please note that DACx0004 has a dedicated bit per channel, this allows the user to set different short circuit limit for different DAC output channels.

**Table 8. Short Circuit Limit Register**

| SHORT CIRCUIT LIMIT REGISTER BITS<br>(D03 – D00) | DAC SHORT CIRCUIT LIMIT                          |
|--------------------------------------------------|--------------------------------------------------|
| 0                                                | DAC output short circuit limit = 40 mA (Default) |
| 1                                                | DAC output short circuit limit = 30 mA           |

### 8.4.8 Status Register

The DACx0004 implements a read-only status register (see [Table 3](#)). This register can be read by using command 1101 on bits D28 – D24, followed by a NOP command.

Logic '1' on bit D04 indicates that the device is ready to be used. This feature is useful to check if the device is ready to accept commands after power up.

## 9 Application and Implementation

### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 9.1 Application Information

### 9.2 Typical Application - Digitally Controlled Asymmetric Bipolar Output

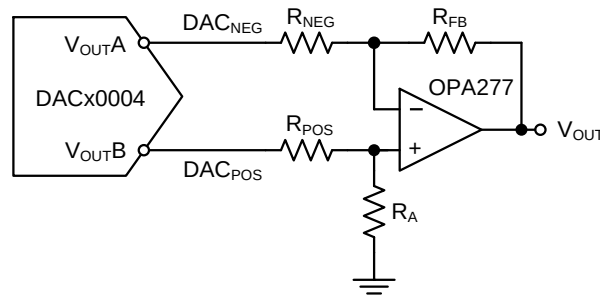


**Figure 58. Asymmetric Bipolar Output Block Diagram**

#### 9.2.1 Design Requirements

This design requires two channels of the DACx0004 to generate a bipolar output. The design is very flexible and allows for many different configurations. Typically, one channel is used to finely control the output, while the other is used to offset the output. The direction of the offset depends on which channel is used as an offset. DAC\_POS provides a positive offset and DAC\_NEG has a negative offset.

#### 9.2.2 Detailed Design Procedure

The output of each DAC can be modified via the digital interface and the gain of each output can be modified independently by changing the external resistors. In order for the gain of each offset to be independent, Equation 2 must be true.

$$R_A = \left( \frac{1}{R_{FB}} + \frac{1}{R_{NEG}} - \frac{1}{R_{POS}} \right)^{-1} \quad (2)$$

The output voltage range, V\_OUT, is adjusted according to Equation 3. Keep in mind that Equation 3 is only true when Equation 2 is true.

$$V_{OUT} = DAC_{POS} \times \frac{R_{FB}}{R_{POS}} - DAC_{NEG} \times \frac{R_{FB}}{R_{NEG}} \quad (3)$$

Each DAC outputs a voltage from 0 to REFIN. As an example, if DAC\_POS gain is 1, DAC\_NEG gain is 2 and R\_FB = 2 kΩ, then R\_POS = 2 kΩ, R\_NEG = 1 kΩ and R\_A = 1 kΩ. With the correct digital implementation it gives the output an effective output range of ±15 V, with discrete 16-bit steps.

## Typical Application - Digitally Controlled Asymmetric Bipolar Output (continued)

### 9.2.3 Application Curve

Figure 59 displays two different modes of operation. Mode 1 gains the output of DAC<sub>Neg</sub> by a factor of 2 and maintains DAC<sub>POS</sub> at unity gain. Mode 2 reverses the gains of each stage to invert the system. These are just two examples of the types of outputs that can be achieved using this configuration.

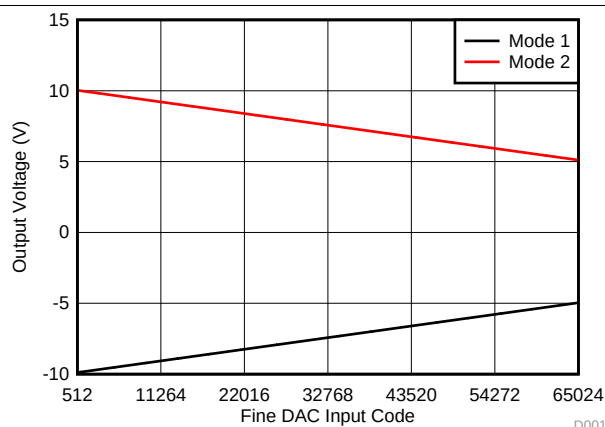


**Figure 59. Output Voltage vs Fine DAC Input Code**

## 10 Power Supply Recommendations

The DACx0004 can operate within the specified supply voltage range of 2.7 V to 5.5 V. The power applied to VDD should be well-regulated and have low-noise. Switching power supplies and DC-DC converters often have high frequency glitches or spikes riding on the output voltage. In addition, digital components can create similar high frequency spikes. This noise can easily couple into the DAC output voltage through various paths between the power connections and analog output. A 1  $\mu$ F to 10  $\mu$ F capacitor and 0.1  $\mu$ F bypass capacitor is recommended in order to further minimize noise from the power supply. The current consumption on the VDD pin, the short-circuit current limit, and the load current for the device are listed in the [Electrical Characteristics](#). The power supply must meet the aforementioned current requirements.

## 11 Layout

### 11.1 Layout Guidelines

A precision analog component requires careful layout, adequate bypassing, and clean, well-regulated power supplies. As a general rule it is important to keep digital traces as far away from analog traces when possible.

The DACx0004 is often used in close proximity with digital logic, microcontrollers, microprocessors, and digital signal processors. The more digital logic present in the design and the higher the switching speed, the more difficult it is to keep digital noise from appearing at the output.

Due to the single ground pin of the DACx0004, all return currents, including digital and analog return currents for the DAC, must flow through a single point. Ideally, GND must be connected directly to an analog ground plane. This plane must be separate from the ground connection for the digital components until they were connected at the power-entry point of the system.

As with the GND connection, VDD should be connected to a 5 V power-supply plane or trace that is separate from the connection for digital logic until they are connected at the power-entry point. It is recommended to have an additional 1  $\mu$ F to 10  $\mu$ F capacitor and 0.1  $\mu$ F bypass capacitor. In some situations, additional bypassing may be required, such as a 100  $\mu$ F electrolytic capacitor or even a Pi filter made up of inductors and capacitors—all designed to essentially low-pass filter the 5 V supply, removing the high-frequency noise. In general it is always a good idea to maintain the digital signals away from analog signals.

### 11.2 Layout Example

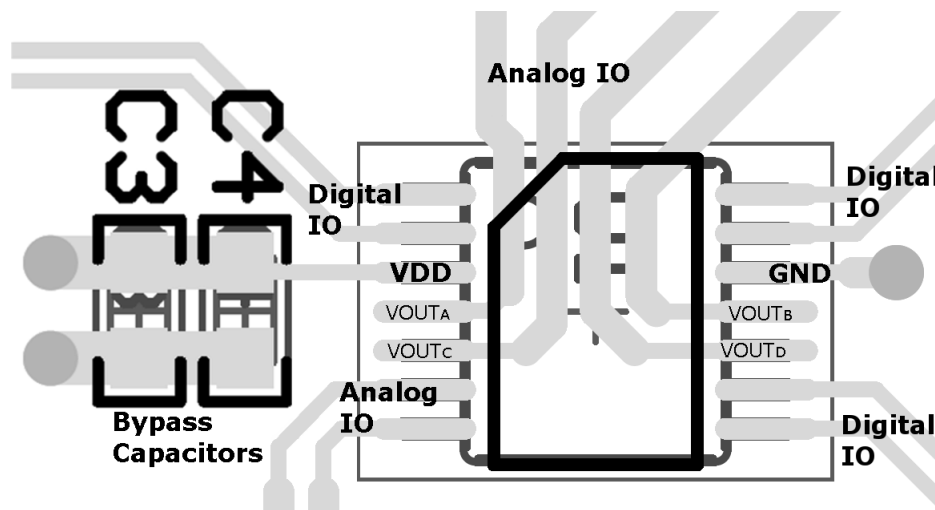


Figure 60. Layout Diagram

## 12 Device and Documentation Support

### 12.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

### 12.2 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 9. Related Links

| PARTS    | PRODUCT FOLDER             | SAMPLE & BUY               | TECHNICAL DOCUMENTS        | TOOLS & SOFTWARE           | SUPPORT & COMMUNITY        |
|----------|----------------------------|----------------------------|----------------------------|----------------------------|----------------------------|
| DAC60004 | <a href="#">Click here</a> | <a href="#">Click here</a> | <a href="#">Click here</a> | <a href="#">Click here</a> | <a href="#">Click here</a> |
| DAC70004 | <a href="#">Click here</a> | <a href="#">Click here</a> | <a href="#">Click here</a> | <a href="#">Click here</a> | <a href="#">Click here</a> |
| DAC80004 | <a href="#">Click here</a> | <a href="#">Click here</a> | <a href="#">Click here</a> | <a href="#">Click here</a> | <a href="#">Click here</a> |

### 12.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

**TI E2E™ Online Community** *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

### 12.4 Trademarks

E2E is a trademark of Texas Instruments.

SPI, QSPI are trademarks of Motorola.

All other trademarks are the property of their respective owners.

### 12.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

### 12.6 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

## 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

DAC80004IPW Device Marking Addendum: Note that both DA80004 and XDC84 are valid Device Markings for the DAC80004IPW Orderable Device

## PACKAGING INFORMATION

| Orderable part number         | Status<br>(1) | Material type<br>(2) | Package   Pins  | Package qty   Carrier | RoHS<br>(3) | Lead finish/<br>Ball material<br>(4) | MSL rating/<br>Peak reflow<br>(5) | Op temp (°C) | Part marking<br>(6) |
|-------------------------------|---------------|----------------------|-----------------|-----------------------|-------------|--------------------------------------|-----------------------------------|--------------|---------------------|
| <a href="#">DAC60004IDMDR</a> | Active        | Production           | VSON (DMD)   14 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA60004             |
| DAC60004IDMDR.B               | Active        | Production           | VSON (DMD)   14 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA60004             |
| <a href="#">DAC60004IDMDT</a> | Active        | Production           | VSON (DMD)   14 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA60004             |
| DAC60004IDMDT.B               | Active        | Production           | VSON (DMD)   14 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA60004             |
| <a href="#">DAC60004IPW</a>   | Active        | Production           | TSSOP (PW)   14 | 90   TUBE             | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA60004             |
| DAC60004IPW.B                 | Active        | Production           | TSSOP (PW)   14 | 90   TUBE             | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA60004             |
| <a href="#">DAC60004IPWR</a>  | Active        | Production           | TSSOP (PW)   14 | 2000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA60004             |
| DAC60004IPWR.B                | Active        | Production           | TSSOP (PW)   14 | 2000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA60004             |
| <a href="#">DAC70004IDMDR</a> | Active        | Production           | VSON (DMD)   14 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA70004             |
| DAC70004IDMDR.B               | Active        | Production           | VSON (DMD)   14 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA70004             |
| <a href="#">DAC70004IDMDT</a> | Active        | Production           | VSON (DMD)   14 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA70004             |
| DAC70004IDMDT.B               | Active        | Production           | VSON (DMD)   14 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA70004             |
| <a href="#">DAC70004IPW</a>   | Active        | Production           | TSSOP (PW)   14 | 90   TUBE             | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA70004             |
| DAC70004IPW.B                 | Active        | Production           | TSSOP (PW)   14 | 90   TUBE             | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA70004             |
| <a href="#">DAC70004IPWR</a>  | Active        | Production           | TSSOP (PW)   14 | 2000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA70004             |
| DAC70004IPWR.B                | Active        | Production           | TSSOP (PW)   14 | 2000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA70004             |
| <a href="#">DAC80004IDMDR</a> | Active        | Production           | VSON (DMD)   14 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA80004             |
| DAC80004IDMDR.B               | Active        | Production           | VSON (DMD)   14 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA80004             |
| <a href="#">DAC80004IDMDT</a> | Active        | Production           | VSON (DMD)   14 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA80004             |
| DAC80004IDMDT.B               | Active        | Production           | VSON (DMD)   14 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA80004             |
| DAC80004IDMDTG4               | Active        | Production           | VSON (DMD)   14 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA80004             |
| DAC80004IDMDTG4.B             | Active        | Production           | VSON (DMD)   14 | 250   SMALL T&R       | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA80004             |
| <a href="#">DAC80004IPW</a>   | Active        | Production           | TSSOP (PW)   14 | 90   TUBE             | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA80004             |
| DAC80004IPW.B                 | Active        | Production           | TSSOP (PW)   14 | 90   TUBE             | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA80004             |
| <a href="#">DAC80004IPWR</a>  | Active        | Production           | TSSOP (PW)   14 | 2000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA80004             |
| DAC80004IPWR.B                | Active        | Production           | TSSOP (PW)   14 | 2000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA80004             |
| DAC80004IPWRG4                | Active        | Production           | TSSOP (PW)   14 | 2000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA80004             |
| DAC80004IPWRG4.B              | Active        | Production           | TSSOP (PW)   14 | 2000   LARGE T&R      | Yes         | NIPDAU                               | Level-2-260C-1 YEAR               | -40 to 125   | DA80004             |

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

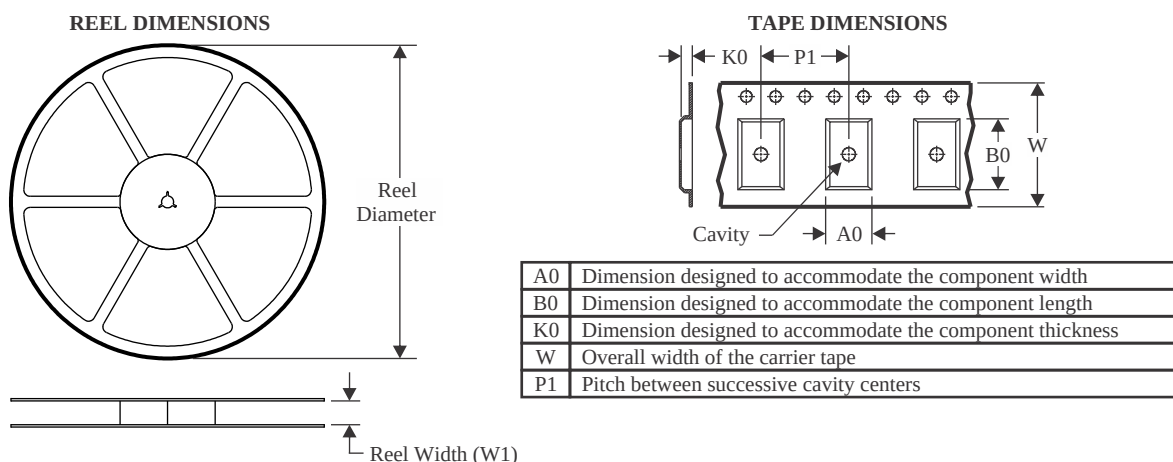
<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

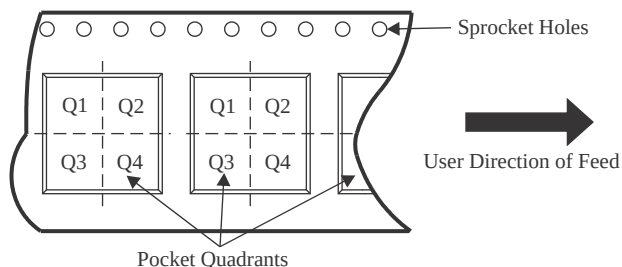
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## TAPE AND REEL INFORMATION



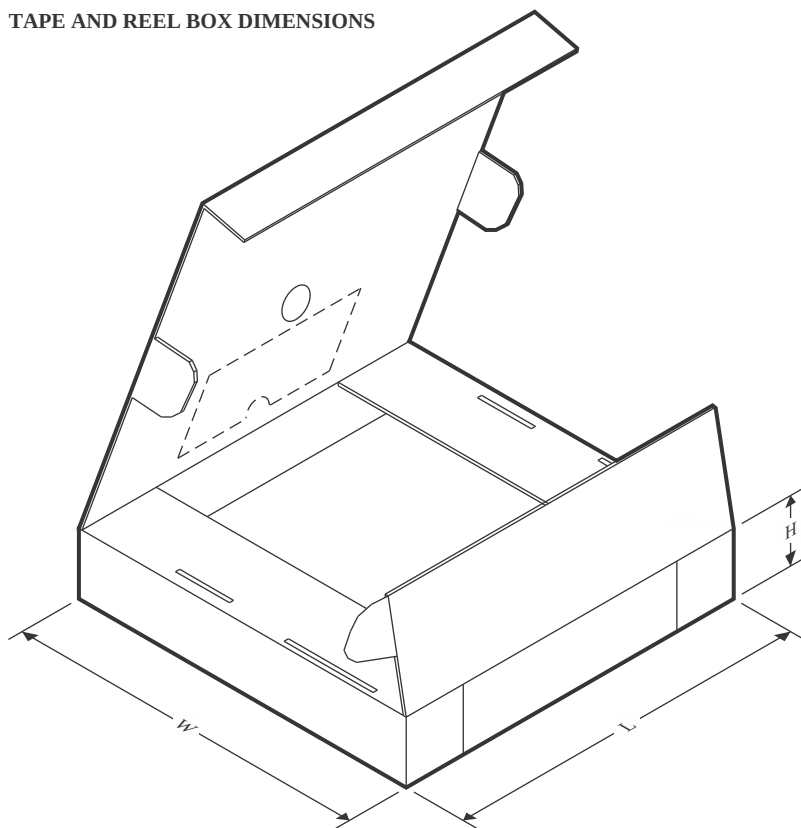
### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



\*All dimensions are nominal

| Device          | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|-----------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| DAC60004IDMDR   | VSON         | DMD             | 14   | 3000 | 330.0              | 12.4               | 3.3     | 4.3     | 1.1     | 8.0     | 12.0   | Q1            |
| DAC60004IDMDT   | VSON         | DMD             | 14   | 250  | 180.0              | 12.4               | 3.3     | 4.3     | 1.1     | 8.0     | 12.0   | Q1            |
| DAC60004IPWR    | TSSOP        | PW              | 14   | 2000 | 330.0              | 12.4               | 6.9     | 5.6     | 1.6     | 8.0     | 12.0   | Q1            |
| DAC70004IDMDR   | VSON         | DMD             | 14   | 3000 | 330.0              | 12.4               | 3.3     | 4.3     | 1.1     | 8.0     | 12.0   | Q1            |
| DAC70004IDMDT   | VSON         | DMD             | 14   | 250  | 180.0              | 12.4               | 3.3     | 4.3     | 1.1     | 8.0     | 12.0   | Q1            |
| DAC70004IPWR    | TSSOP        | PW              | 14   | 2000 | 330.0              | 12.4               | 6.9     | 5.6     | 1.6     | 8.0     | 12.0   | Q1            |
| DAC80004IDMDR   | VSON         | DMD             | 14   | 3000 | 330.0              | 12.4               | 3.3     | 4.3     | 1.1     | 8.0     | 12.0   | Q1            |
| DAC80004IDMDT   | VSON         | DMD             | 14   | 250  | 180.0              | 12.4               | 3.3     | 4.3     | 1.1     | 8.0     | 12.0   | Q1            |
| DAC80004IDMDTG4 | VSON         | DMD             | 14   | 250  | 180.0              | 12.4               | 3.3     | 4.3     | 1.1     | 8.0     | 12.0   | Q1            |
| DAC80004IPWR    | TSSOP        | PW              | 14   | 2000 | 330.0              | 12.4               | 6.9     | 5.6     | 1.6     | 8.0     | 12.0   | Q1            |
| DAC80004IPWRG4  | TSSOP        | PW              | 14   | 2000 | 330.0              | 12.4               | 6.9     | 5.6     | 1.6     | 8.0     | 12.0   | Q1            |

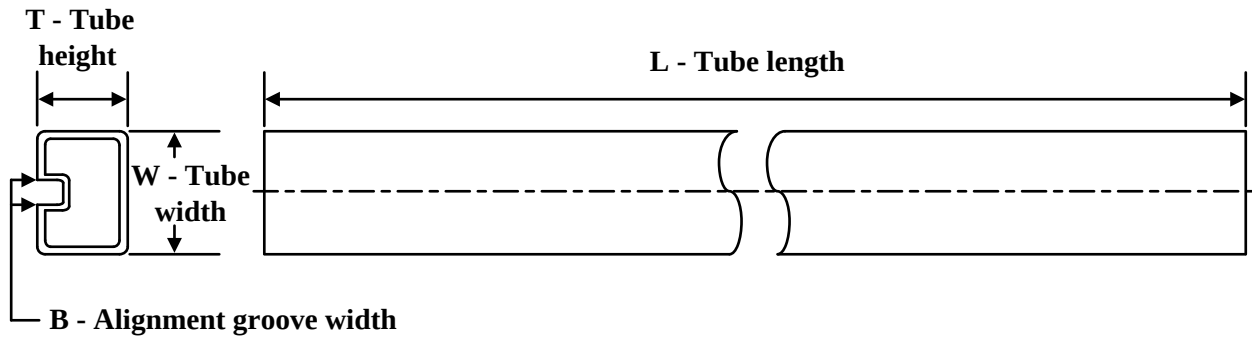
## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

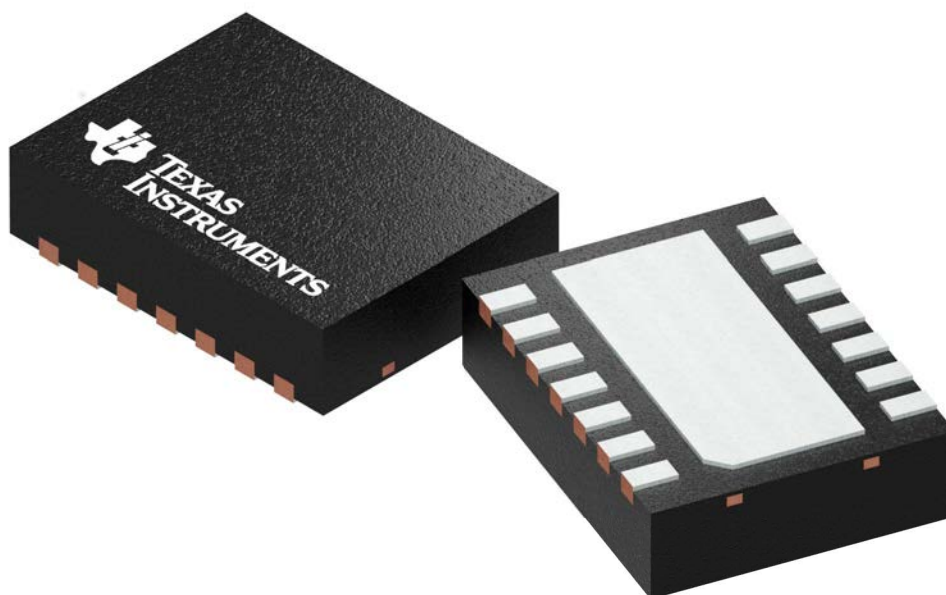
| Device          | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|-----------------|--------------|-----------------|------|------|-------------|------------|-------------|
| DAC60004IDMDR   | VSON         | DMD             | 14   | 3000 | 367.0       | 367.0      | 38.0        |
| DAC60004IDMDT   | VSON         | DMD             | 14   | 250  | 213.0       | 191.0      | 35.0        |
| DAC60004IPWR    | TSSOP        | PW              | 14   | 2000 | 353.0       | 353.0      | 32.0        |
| DAC70004IDMDR   | VSON         | DMD             | 14   | 3000 | 367.0       | 367.0      | 38.0        |
| DAC70004IDMDT   | VSON         | DMD             | 14   | 250  | 213.0       | 191.0      | 35.0        |
| DAC70004IPWR    | TSSOP        | PW              | 14   | 2000 | 353.0       | 353.0      | 32.0        |
| DAC80004IDMDR   | VSON         | DMD             | 14   | 3000 | 367.0       | 367.0      | 38.0        |
| DAC80004IDMDT   | VSON         | DMD             | 14   | 250  | 213.0       | 191.0      | 35.0        |
| DAC80004IDMDTG4 | VSON         | DMD             | 14   | 250  | 213.0       | 191.0      | 35.0        |
| DAC80004IPWR    | TSSOP        | PW              | 14   | 2000 | 353.0       | 353.0      | 32.0        |
| DAC80004IPWRG4  | TSSOP        | PW              | 14   | 2000 | 353.0       | 353.0      | 32.0        |

## TUBE

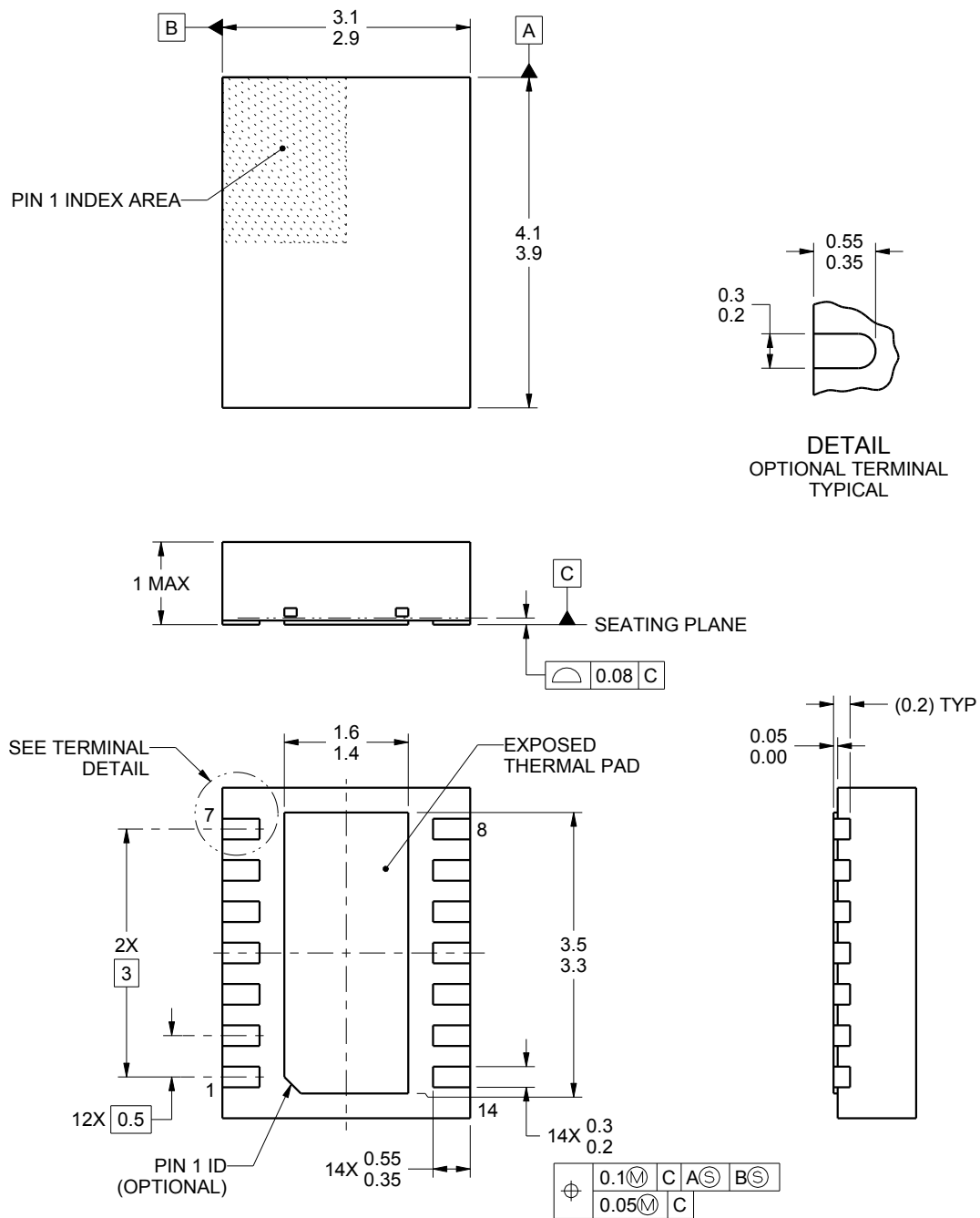
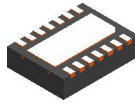


\*All dimensions are nominal

| Device        | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | T (μm) | B (mm) |
|---------------|--------------|--------------|------|-----|--------|--------|--------|--------|
| DAC60004IPW   | PW           | TSSOP        | 14   | 90  | 530    | 10.2   | 3600   | 3.5    |
| DAC60004IPW.B | PW           | TSSOP        | 14   | 90  | 530    | 10.2   | 3600   | 3.5    |
| DAC70004IPW   | PW           | TSSOP        | 14   | 90  | 530    | 10.2   | 3600   | 3.5    |
| DAC70004IPW.B | PW           | TSSOP        | 14   | 90  | 530    | 10.2   | 3600   | 3.5    |
| DAC80004IPW   | PW           | TSSOP        | 14   | 90  | 530    | 10.2   | 3600   | 3.5    |
| DAC80004IPW.B | PW           | TSSOP        | 14   | 90  | 530    | 10.2   | 3600   | 3.5    |



Images above are just a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.



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## NOTES:

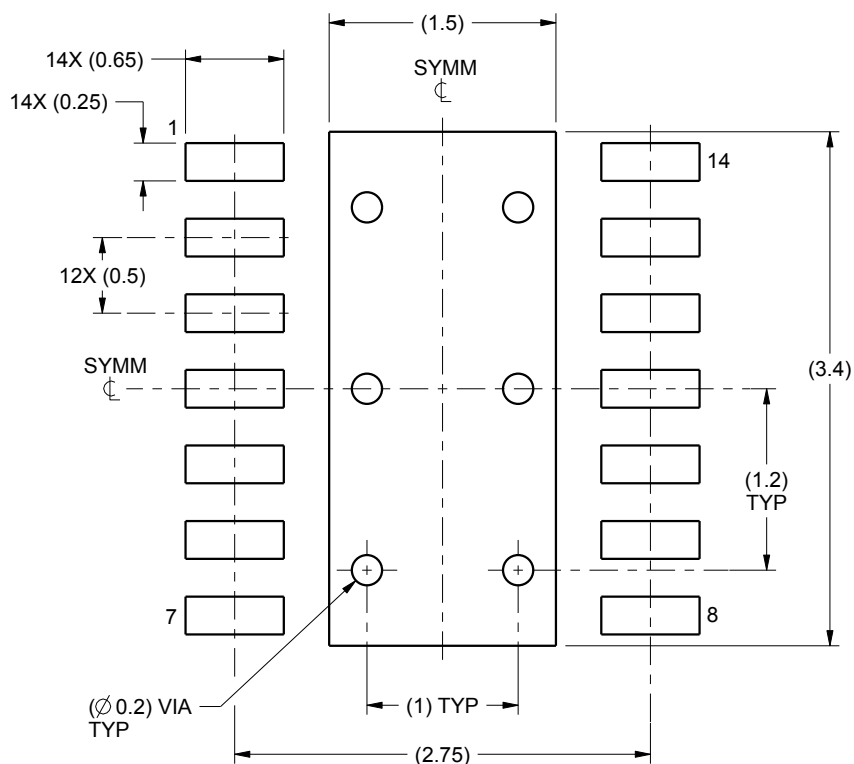
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

# EXAMPLE BOARD LAYOUT

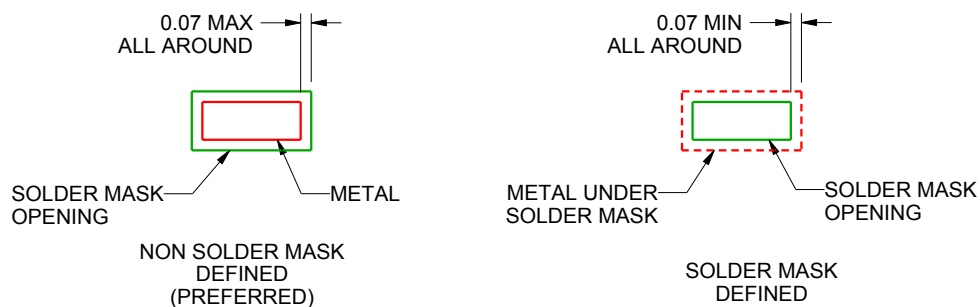
DMD0014A

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE  
SCALE:20X



SOLDER MASK DETAILS

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NOTES: (continued)

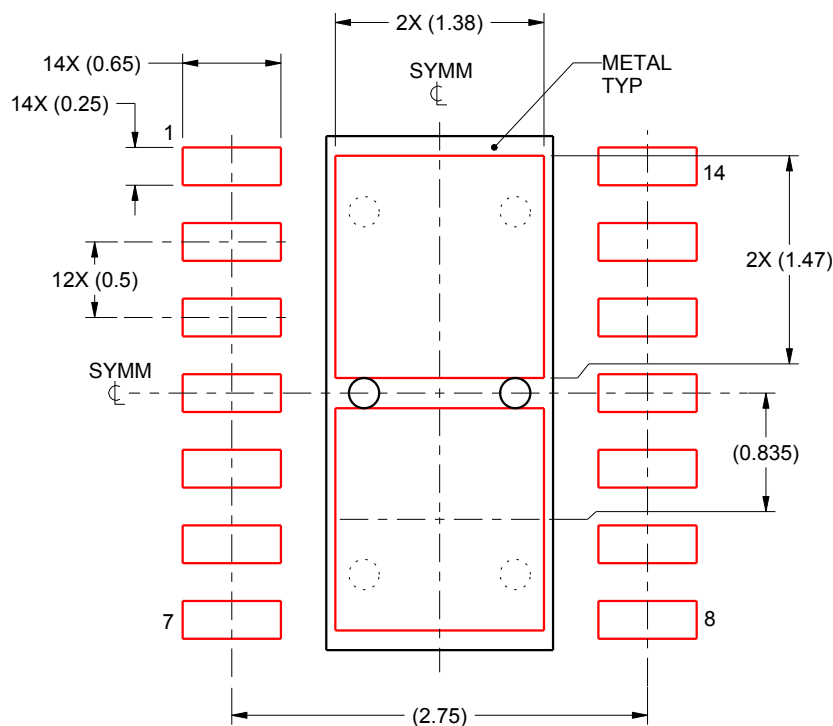
4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 ([www.ti.com/lit/sluea271](http://www.ti.com/lit/sluea271)).
5. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

## EXAMPLE STENCIL DESIGN

DMD0014A

VSON - 1 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD  
80% PRINTED SOLDER COVERAGE BY AREA  
SCALE:20X

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NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

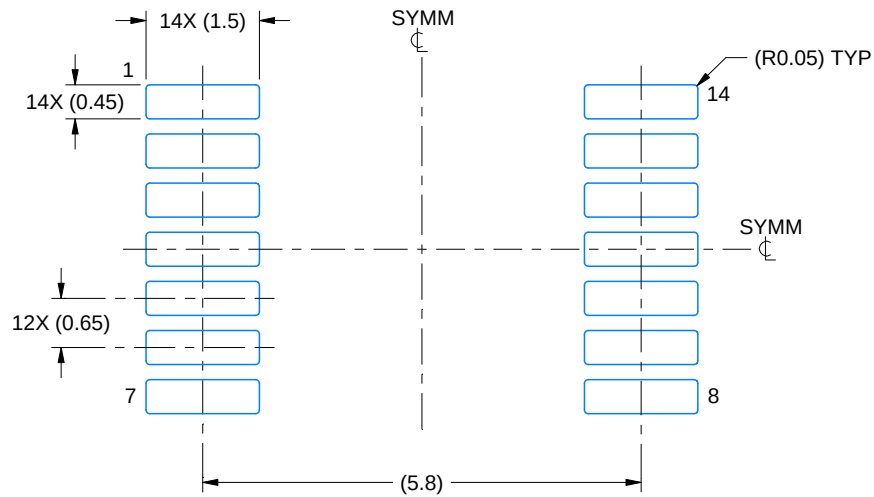


# EXAMPLE BOARD LAYOUT

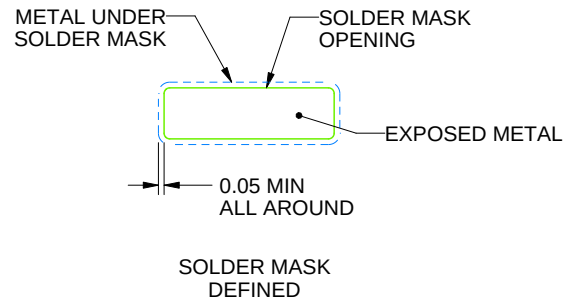
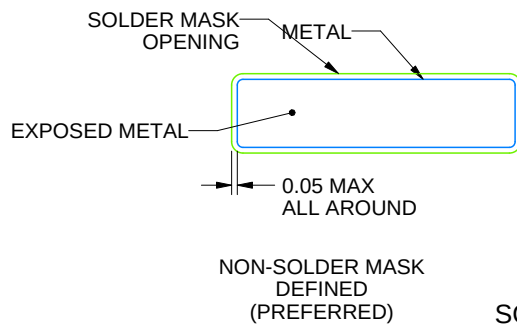
PW0014A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 10X



SOLDER MASK DETAILS

4220202/B 12/2023

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

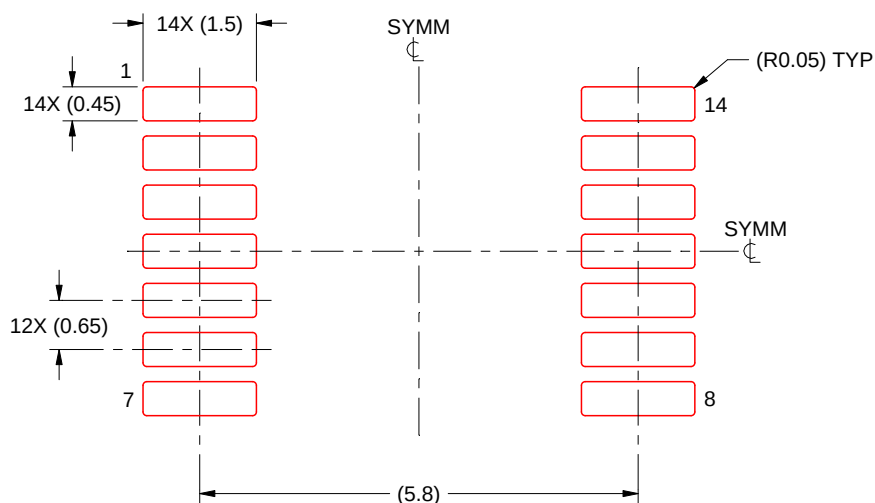
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

PW0014A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE: 10X

4220202/B 12/2023

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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